



# **IQS620A** Datasheet

Combination sensor with dual channel capacitive proximity/touch, Hall-effect and inductive sensing

The IQS620A ProxFusion<sup>®</sup> IC is a multifunctional capacitive, Hall-effect & inductive sensor designed for applications where any or all of the technologies may be required. The IQS620A is an ultra-low power solution designed for short or long term activations through any of the sensing channels. The IQS620A is fully I<sup>2</sup>C compatible and can be configured to output main trigger events on GPIOs.

#### Features

- > Unique combination of sensing technologies:
  - > Capacitive sensing
  - > Hall-effect sensing
  - > Inductive sensing
- > Capacitive sensing
  - > Full auto-tuning with adjustable sensitivity
  - > 2pF to 200pF external capacitive load capability
- > Enhanced temperature stability
- > Hall-effect sensing
  - > On-chip Hall-effect measurement plates
  - > Dual direction Hall switch sensor UI
  - > 2 level detection (widely variable)
  - > Detection range 10mT 200mT
- > Inductive sensing
  - > 2 level adjustable detection and hysteresis
  - > External sense coil required (PCB trace)
- Multiple integrated UI options based on years of experience in sensing on fixed and mobile platforms:
  - Proximity wake-up; Touch; SAR; Hysteresis
  - Automatic Tuning Implementation (ATI) -
- performance enhancement (10bit)
- > Minimal external components
- > Standard I<sup>2</sup>C interface
  - > Optional RDY signal for event mode operation

#### Applications

>

- Mobile electronics (phones/tablets)
- SAR safety requirements for laptops, tablets and phones
- > Wearable devices
- > White goods and appliances

#### RoHS & Reach Compliant



Representations only, not actual marking

- Low power consumption:
  - > 130µA (100Hz response, 1ch inductive)
  - > 105µA (100Hz response, 2ch Hall)
  - > 90µA (100Hz response, 3ch capacitive)
  - > 75µA (100Hz response, 1ch cap. SAR)
  - > 46µA (20Hz response, 1ch inductive)
  - > 38µA (20Hz response, 2ch Hall)
  - > 32µA (20Hz response, 3ch capacitive)
  - > 27µA (20Hz response, 1ch cap. SAR)
  - > 2.5µA (4Hz response, 1ch cap. wake-up)
  - Supply voltage:
    - > IQS620A: 1.8V (-2%) to 3.3V
- Low profile packages:
  - > DFN(3x3)-10 (3 x 3 x 0.8mm) 10 pin
  - > WLCSP-9 (1.53 x 1.07 x 0.34mm) 9 pin
- > Human Interface Devices
- > Proximity activated backlighting
- > Applications with long-term activation
- > Aftermarket automotive<sup>1</sup>

	Available Packages	
TA	DFN(3x3)-10	WLCSP-9
-20°C to +85°C	IQS620AzDNR	IQS620AzCSR

#### <sup>1</sup> The part is not automotive qualified.





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# List of abbreviations

	relations
AC	<ul> <li>Alternating Current</li> </ul>
ACK	<ul> <li>– I<sup>2</sup>C Acknowledge condition</li> </ul>
ATI	- Automatic Tuning Implementation
BOD	<ul> <li>Brown Out Detection</li> </ul>
CS	<ul> <li>Sampling Capacitor</li> </ul>
DSP	<ul> <li>Digital Signal Processing</li> </ul>
ESD	<ul> <li>Electrostatic Discharge</li> </ul>
FOSC	<ul> <li>Main Clock Frequency Oscillator</li> </ul>
GND	– Ground
GPIO	<ul> <li>– General Purpose Input Output</li> </ul>
I <sup>2</sup> C	<ul> <li>Inter-Integrated Circuit</li> </ul>
IC	<ul> <li>Integrated Circuit</li> </ul>
LP	– Low Power
LPOSC	<ul> <li>Low Power Oscillator</li> </ul>
LTA	– Long Term Average
LTX	<ul> <li>Inductive Transmitting electrode</li> </ul>
MCU	<ul> <li>Microcontroller unit</li> </ul>
MSL	<ul> <li>Moisture Sensitive Level</li> </ul>
MOV	– Movement
MOQ	<ul> <li>Minimum Order Quantity</li> </ul>
NACK	<ul> <li>– I<sup>2</sup>C Not Acknowledge condition</li> </ul>
NC	– Not Connect
NP	– Normal Power
OTP	<ul> <li>One Time Programmable</li> </ul>
PMU	– Power Management Unit
POR	– Power On Reset
PWM	<ul> <li>Pulse Width Modulation</li> </ul>
QRD	<ul> <li>– Quick Release Detection</li> </ul>
RDY	<ul> <li>Ready Interrupt Signal</li> </ul>
RX	<ul> <li>Receiving electrode</li> </ul>
SAR	<ul> <li>Specific Absorption Rate</li> </ul>
SCL	– I <sup>2</sup> C Clock
SDA	– I <sup>2</sup> C Data
SR	– I <sup>2</sup> C Slew rate
THR	- Threshold
UI	– User Interface
ULP	– Ultra Low Power





#### 1 Introduction

#### 1.1 ProxFusion®

The ProxFusion<sup>®</sup> sensor series provides all of the proven ProxSense<sup>®</sup> engine capabilities with additional sensors types. A combined sensor solution is available within a single platform.

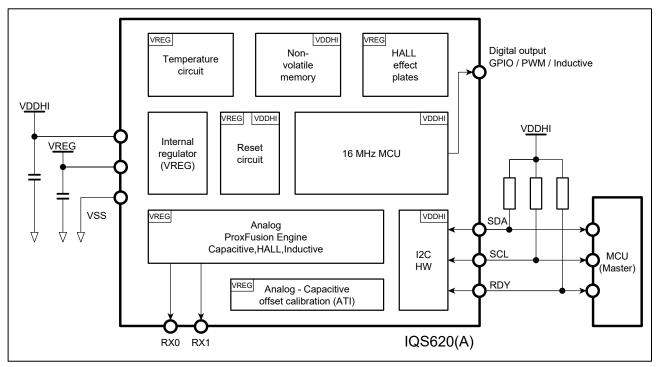


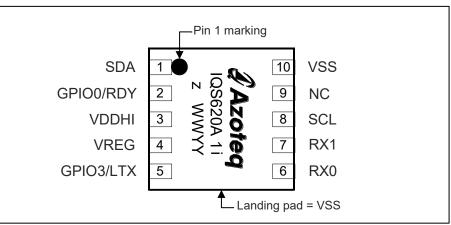
Figure 1.1 IQS620A functional block diagram





# 1.2 Packaging and Pin-Out

# 1.2.1 DFN(3x3)-10



# Figure 1.2IQS620A pin-out (DFN(3x3)-10 package top view; markings may differ)Table 1.1DFN(3x3)-10 pin-out description

	IQS620A in DFN(3x3)-10						
Pin Name Type		Туре	Function				
1	SDA	Digital input / output	SDA (I <sup>2</sup> C Data signal)				
2	GPIO0 / RDY	Digital output Open drain active low logic	SAR activation output (higher priority) <b>RDY</b> (I <sup>2</sup> C Ready interrupt signal; lower priority)				
3	VDDHI	Supply input	Supply: IQS620A: 1.8V(-2%) – 3.3V				
4	VREG	Voltage regulator output	Regulates the system's internal voltage Requires external capacitors to ground				
5	GPIO3 / LTX	Digital output / Analogue transmitter electrode	PWM signal output (higher priority) / Connect to inductive sensor's transmitting coil (lower priority)				
6	RX0	Analogue receiving electrode	Connect to conductive area intended for sensor receiving				
7	RX1	Analogue receiving electrode	Connect to conductive area intended for sensor receiving				
8	SCL	Digital input / output	SCL (I <sup>2</sup> C Clock signal)				
9	NC	Not connect	Not connect				
10	VSS	Supply input	Common ground reference				





## 1.2.2 WLCSP-9

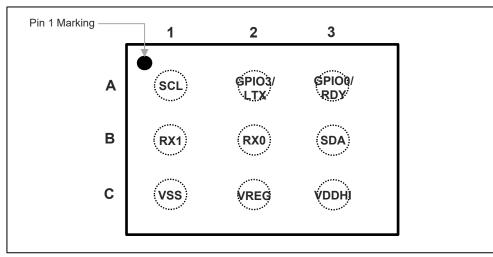


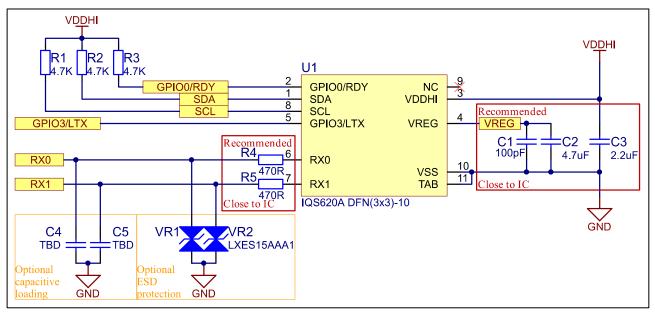
Figure 1.3 IQS620A pin-out (WLCSP-9 package top view; markings may differ) Table 1.2 WLCSP-9 pin-out description

	IQS620A in WLCSP-9						
Pin Name Type		Туре	Function				
A1	SCL	Digital input / output	SCL (I <sup>2</sup> C Clock signal)				
A2	GPIO3 / LTX	<ul> <li>B / Digital output /</li> <li>Analogue transmitter electrode</li> <li>PWM signal output (higher priority) /</li> <li>Connect to inductive sensor's transmitting coil priority)</li> </ul>					
A3	GPIO0 / RDY	Digital output Open drain active low logic	SAR activation output (higher priority) <b>RDY</b> (I <sup>2</sup> C Ready interrupt signal; lower priority)				
B1	RX1	Analogue receiving electrode	Connect to conductive area intended for sensor receiving				
B2	32   RX0   Analogue receiving electrode		Connect to conductive area intended for sensor receiving				
B3	SDA	Digital input / output	SDA (I <sup>2</sup> C Data signal)				
C1	VSS	Supply input	Common ground reference				
C2	VREG	Voltage regulator output	Regulates the system's internal voltage Requires external capacitors to ground				
C3	VDDHI	Supply input	Supply: IQS620A: 1.8V(-2%) – 3.3V				





#### 1.3 Reference schematic





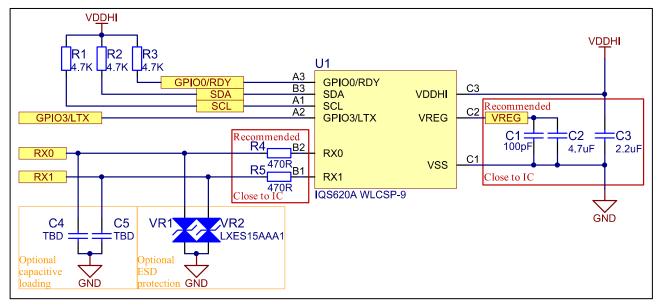


Figure 1.5 IQS620A WLCSP-9 reference schematic

#### Please note:

- C1, C2 and C3 should be placed as close as possible to the IQS620A package and should terminate using the shortest possible path to the IQS GND connection pin.
- R4 & R5 are recommend 0603 ESD protection resistors but also aid in sensor RF immunity. The values can be increased up to 4kΩ for severe RF noise environments.
- C4 & C5 are optional loading capacitors and should only be used if intended to de-sensitize sensors or match one sensor's capacitive load with another electrode implementation.
- VR1 & VR2 are optional TVS diodes for ESD clamping and noise suppression. Ensure the correct layout principles are followed when placed and routed.





#### 1.3.2 Recommended VREG and VDDHI capacitor ratio

For supplies with low in-line resistance and high current output capability is it recommended to ensure  $C_{VREG} > 2C_{VDDHI}$ . This is to prevent a known ESD risk.

Known risk: The IQS620A will not recover from ESD events if the following conditions are met:

- > VDDHI source is present with low impedance path and high current sourcing capability
- > C<sub>VDDHI</sub> > C<sub>VREG</sub>

With these conditions met, the source keeps VDDHI above the BOD<sub>VDDHI</sub> level during the ESD event but drains the VREG capacitor during sleep mode causing a unique sleep-mode BOD event keeping the IC in reset. This only recovers when forcing a POR on VDDHI.

For supplies with a high in-line resistance (such as battery with high series resistance) it is recommended to ensure  $C_{VDDHI} > C_{VREG}$  to prevent an unexpected dip on VDDHI when the sensor wakes from sleep-mode and re-charging the VREG capacitor.

#### Table 1.3 C<sub>VREG</sub> minimum and recommended C<sub>VDDH</sub> capacitor values

Report rate minimum (Slowest sampling rate allowed)	15.625Hz (64ms)	7.8Hz (128ms)	6.25Hz (160ms)	3.9Hz (256ms)	Recommended for general design
C <sub>VREG</sub> minimum <sup>*</sup>	2.2µF	2.2µF	3.3µF	3.9µF	4.7µF
C <sub>VDDHI</sub> recommended <sup>†</sup>	1µF	1µF	1.5µF	1.5µF	2.2µF
Suitable for Hall-effect	No	No	No	No	Yes

For applications that requires Hall-effect channel conversions a minimum  $C_{VREG} = 4.7 \mu F$  is mandatory to ensure stable regulation during Hall-effect plate sampling.

<sup>\*</sup> Based on sleep mode current consumption of " $I_{sleep}$ " with starting voltage "VREG" minimum voltage and discharge voltage > BOD<sub>VREG</sub> maximum at the end of the sleep period

<sup>&</sup>lt;sup>†</sup> Based on  $C_{VREG} > 2C_{VDDHI}$ 





# **1.4 Sensor channel combinations**

The table below summarizes the IQS620A's sensor and channel associations.

Table 1.4Sensor - channel allocation

	Sensor / UI type	CH0	CH1	CH2	CH3	CH4	CH5
	Self capacitive	0	o	0			
Capacitive	SAR UI 1CH self (2 level + movement)	• Main	• Movement				
Capa	SAR UI 2CH self (3 level)	٠	•	٠			
	Hysteresis UI			٠			
Hall-effect	Hall-effect switch UI					• Positive	• Negative
0	Inductive resonant tank	0	o	0			
Inductive	Inductive mutually coupled coils	0	0	0			
_	Hysteresis UI			٠			
Temperature	Temperature monitoring				•		

Key:

O - Optional implementation

Fixed use for UI





# **1.5 ProxFusion<sup>®</sup> Sensitivity**

The measurement circuitry uses a temperature stable internal sample capacitor ( $C_s$ ) and internal regulated voltage ( $V_{REG}$ ). Internal regulation provides for more accurate measurements.

The Automatic Tuning Implementation (ATI) is a sophisticated technology implemented on the ProxFusion<sup>®</sup> device series. It allows for optimal performance of the devices for a wide range of sense electrode capacitances, without modification or addition of external components. The ATI functionality ensures that sensor sensitivity is not affected by external influences such as temperate, parasitic capacitance and ground reference changes.

The ATI process adjusts three values (Coarse multiplier, Fine multiplier, Compensation) using two parameters (ATI base and ATI target) as inputs. A 10-bit compensation value ensures that an accurate target is reached. The base value influences the overall sensitivity of the channel and establishes a base count for the ATI algorithm. A rough estimation of sensitivity can be approximated using the relation:

# Sensitivity $\propto \frac{Target}{Base}$

As seen from this equation, the sensitivity can be increased by either increasing the Target value or decreasing the Base value. A lower base value will typically result in lower multipliers and more compensation would be required. It should, however, be noted that a higher sensitivity will yield a higher noise susceptibility. Refer to Appendix B for more information regarding Hall-effect ATI.



# 2 Capacitive sensing

# 2.1 Introduction to ProxSense®

Building on the previous successes from the ProxSense<sup>®</sup> range of capacitive sensors, the same fundamental sensor engine has been implemented in the ProxFusion<sup>®</sup> series.

The capacitive sensing capabilities of the IQS620A include:

- Self-capacitive sensing.
- Maximum of 3 capacitive channels to be individually configured.
  - o Individual sensitivity setups
  - Alternative ATI modes
- Discreet button UI:
  - Fully configurable 2 level threshold setups for prox & touch activation levels.
  - Customizable filter halt time
- Single channel SAR UI:
  - For passing the SAR qualification
  - Movement sensing to distinguish between stationary in-contact objects and human interference
  - Quick release detection feature (fully configurable)
  - o GPIO output of SAR activation (on GPIO0) for driving e.g. WWAN module directly
  - Up to three triggers levels (proximity, touch and deep touch) for dynamic power reduction
  - All triggers offer never time-out capability
- Two Channel SAR UI:
  - For passing the SAR qualification latest requirements (EN50566)
  - Up to three dedicated triggers levels per sensor for dynamic power reduction
  - All triggers offer never time-out capability
- Hysteresis UI:
  - o 4 Optional prox and touch activation hysteresis selections.
  - Fully configurable 2 level threshold setups for prox & touch activation levels.
  - Customizable filter halt time





# 2.2 Channel specifications

The IQS620A provides a maximum of 3 channels available to be configured for capacitive sensing. Each channel can be setup separately according to the channel's associated settings registers.

There are three distinct capacitive user interfaces available to be used.

- a) Self capacitive proximity/touch UI
- b) SAR UIs
- c) Hysteresis UI

When the single channel SAR UI is activated (ProxFusion Settings4: bit7-6):

- Channel 0 is used for the main capacitive sensing channel for SAR detection and release detection.
- Channel 1 is used for capacitive movement detection.

When the two channel SAR UI is active (ProxFusion Settings4: bit7-6):

- Channel 0 & 1 is used for the first or main SAR antenna sensor (Rx0)
- Channel 2 is used for a second SAR antenna sensor (Rx1)

Mode	CH0	CH1	CH2	CH3	CH4	CH5
Self capacitive	0	0	0			
Single SAR UI self	• Main	• Movement				
Two channel SAR UI self	٠	٠	٠			
Hysteresis UI			٠			

Key:

- O Optional implementation
- Fixed use for UI

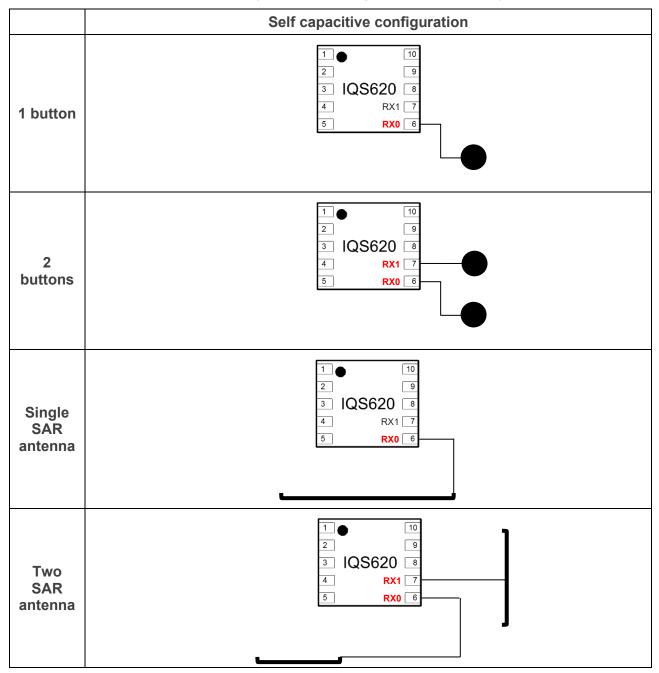




# 2.3 Hardware configuration

In the table below are multiple options of configuring sensing (Rx) electrodes to realize different implementations (combinations not shown).









#### 2.4 Software configuration

#### 2.4.1 Registers to configure for capacitive sensing:

#### Table 2.3 Capacitive sensing settings registers

Address	Name	Description	Recommended setting
0x40 0x41 0x42	11 configuration of each channel.		Sensor mode should be set to capacitive mode An appropriate RX should be chosen
UN IU		Channel settings for the ProxSense sensors	Full ATI is recommended for fully automated sensor tuning.
0x46 0x47 0x48	ProxFusion Settings 2	ATI settings for ProxSense sensors	ATI target should be more than ATI base to achieve an ATI
0x49 0x4A 0x4B	ProxFusion Settings 3	Additional Global settings for ProxSense sensors	None
0x50	ProxFusion Settings 4	UI enable command and filter settings	Choose Normal 2 Channel, Single SAR or 3 level dual SAR UI
0x51	ProxFusion Settings 5	Advance sensor settings	None

#### 2.4.2 Registers to configure for the standard UI (proximity / touch):

Please note: If the standard UI (proximity / touch) is used then the single SAR UI (proximity / touch / movement) cannot be used and the special SAR registers should not be configured or used. Initializing inactive UI registers can corrupt other active UI's.

#### Table 2.4 standard UI settings registers

Address	Name	Description
0x60 0x62 0x64	Proximity threshold	Proximity Thresholds for all capacitive channels (except for single channel SAR active on channel 0)
0x61 0x63 0x65	Touch threshold	Touch Thresholds for all capacitive channels
0x66	ProxFusion standard UI halt time	Halt timeout setting for all capacitive channels

#### 2.4.3 Registers to configure for the two channel SAR UI (proximity / touch / deep touch):

Please note: If the two channel SAR UI is used then the special SAR UI registers (proximity, movement, release detection) cannot be used and the settings registers should be used as shown in the table below. Initializing inactive UI registers can corrupt other active UI's.





# Table 2.5Two channel SAR UI settings registers

Address	Name	Description
0x50	ProxFusion settings 4	Two channel SAR UI enable command (bit7-6).
0x80	Hysteresis settings	Disable Hysteresis for proximity and touch thresholds
0x60	CH0 Proximity threshold	SAR Antenna 1 proximity threshold
0x61	CH0 Touch threshold	SAR Antenna 1 touch threshold
0x63	CH1 Touch threshold	SAR Antenna 1 deep touch threshold
0x81	CH2 filter halt threshold	SAR Antenna 2 proximity threshold
0x82	CH2 proximity threshold	SAR Antenna 2 touch threshold
0x83	CH2 touch threshold	SAR Antenna 2 deep touch threshold
	ProxFusion standard UI	Halt timeout setting for all capacitive channels. Set to 0xFF for no
0x66	halt time	time-out as required by SAR applications





#### 2.4.4 Registers to configure for the single channel SAR UI:

Please note: If the single SAR UI is used then the discreet button UI cannot be used and the ProxFusion discrete UI settings registers should not be configured or used. Initializing inactive UI registers can corrupt other active UI's.

Address	Name	Description
0x50	ProxFusion settings 4	Single channel SAR UI (prox / touch / movement) enable command (bit7-6).
0.70	SAR UI Settings 0	Filter settings for movement and QRD,
0x70		SAR activation output to GPIO0 (RDY signal disabled)
0x71	SAR UI Settings 0	LTA halt timeout and movement threshold settings
0x72	Quick release threshold	Threshold setting to trigger a quick release based on the Quick
OXI 2	Ch0	release count values in register 0xF2 & 0xF3.
0x73	Filter halt threshold Ch0	Threshold value for channel 0 LTA filter halt
0x74	SAR Proximity threshold	Proximity threshold used for SAR activations on channel 0
UX14	Ch0	
0x75	Quick release halt time	Halt timeout setting for channel 0 LTA after a quick release trigger
UNI U		with zero movement

# Table 2.6Single channel SAR UI settings registers

#### 2.4.5 Registers to configure for the Hysteresis UI:

Please note: Only channel 2 can be used with the Hysteresis UI. Please setup channel 2 accordingly if required. The Hysteresis UI can be used simultaneously with the discrete button UI or SAR UI.

#### Table 2.7 Hysteresis UI settings registers

Address	Name	Description
0x50	ProxFusion settings 4	Hysteresis UI enable command (bit6).
0x80	Hysteresis UI settings	Hysteresis selection options for prox and touch activations
0x81	Hysteresis UI filter halt threshold	UI filter halt threshold value to halt the LTA value from following
0x82	Hysteresis UI prox threshold	Threshold setting to trigger a prox activation on channel 2 data.
0x83	Hysteresis UI touch threshold	Threshold value to trigger a touch activation on channel 2 data.

#### 2.4.6 Example code:

Example code for an Arduino Uno can be downloaded at:

www.azoteq.com//images/stories/software/IQS62x\_Demo.zip





# 2.5 Sensor data output and flags

The following registers should be monitored by the master to detect capacitive sensor output and SAR activations.

a) The Global events register (0x11) will show the IQS620A's main events. Bit0 is dedicated to the ProxSense activations and two other bits (bit7 & bit1) is provided to show the state of the single channel SAR UI. SINGLE\_SAR\_ACTIVE (bit7) will be constantly active during SAR detection. SAR event (bit1) will toggle upon each SAR qualified event or change of SAR status. Bit3 is dedicated to the Hysteresis UI activations (for ch2 data only).

	Global Events (0x11)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R	R	R	R	R	R	R	R				
Name	SINGLE SAR ACTIVE	PMU EVENT	SYS EVENT	TEMP EVENT	HYSTE- RESIS UI EVENT	HALL EVENT	SINGLE SAR EVENT	PROX SENSE EVENT				

- b) The **ProxFusion UI flags (0x12)** and **SAR UI flags (0x13)** provide more detail regarding the outputs. A prox and touch output bit for each channel 0 to 2 is provided in the ProxFusion UI flags register.
- c) The SAR UI Flags (0x13) register will show detail regarding the state of the SAR output as well as Quick release toggles, movement activations and the state of the filter (halted or not). The SAR UI can also be used with the inductive sensing capabilities and is explained in section 4. Inductive sensing.

			ProxFus	sion UI flag	js (0x12)			
Bit Number	7	6	5	4	3	2	1	0
Data Access	-	R	R	R	-	R	R	R
Name	-	CH2_T	CH1_T	CH0_T	-	CH2_P	CH1_P	CH0_P
			SAR	UI flags (0	)x13)			
Bit Number	7	6	5	4	3	2	1	0
Data Access	-	-	-	R	-	R	R	R
Name	-	-	-	SAR ACTIVE	-	QUICK RELEASE	MOVE- MENT	FHALT
			Hystere	esis UI flag	s (0x13)			
Bit Number	7	6	5	4	3	2	1	0
Data Access	R	R	R	-	-	-	-	-
Name	Signed output	тоисн	PROX	-	-	-	-	-

d) When the "Two channel SAR UI" is chosen for proximity, touch and deep touch on two channels, the ProxFusion UI flags and Hysteresis UI flags are defined as shown below:



IQ Switch® ProxFusion® Series



		-	<b>Fwo chann</b>	el SAR UI 1	flags (0x12	)		
Bit Number	7	6	5	4	3	2	1	0
Data Access	-	R	R	R	-	R	R	R
Name	-	-	ANT 1 DEEP TOUCH	ANT 1 TOUCH	-	ANT 2 PROX	-	ANT 1 PROX
		Т	wo channe	I SAR UI fl	ags 2 (0x1	3)		
Bit Number	7	6	5	4	3	2	1	0
Data Access	R	R	R	R	-	R	R	R
Name	-	ANT 2 DEEP TOUCH	ANT 2 TOUCH	-	-	-	-	-



# 3 Hall-effect sensing

# 3.1 Introduction to Hall-effect sensing

The IQS620A has an internal Hall-effect sensing plate (on chip). No external sensing hardware is required for Hall-effect sensing.

The Hall-effect sensor measures the generated voltage difference across the plate, which can be modelled as a Wheatstone bridge. The voltage difference is converted to a current using an operational amplifier in order to be measured by the same ProxSense<sup>®</sup> sensor engine.

Advanced digital signal processing is performed to provide sensible output data.

- Two threshold levels are provided (prox & touch).
- Hall-effect output can be linearized through a selectable inverse calculator option.
- North/South field direction indication provided.
- Differential Hall-Effect sensing:
  - Removes common mode disturbances
  - North-South field indication

#### 3.2 Channel specifications

Channels 4 and 5 are dedicated to Hall-effect sensing. Channel 4 performs the positive direction measurements and channel 5 will handle all measurements in the negative direction. These two channels are used in conjunction to acquire differential Hall-effect data and will always be used as input data to the Hall-effect UI's.

There are two distinct Hall-effect user interfaces available:

- a) General Hall-effect sensing
- b) Hall-effect switch UI

#### Table 3.1 Hall-effect sensor – channel allocation

Mode	CH0	CH1	CH2	CH3	CH4	CH5
Hall-effect switch Ul						
Smart cover					• Positive	• Negative
Slide switch						

Key:

- O Optional implementation
- - Fixed use for UI





# 3.3 Hardware configuration

Rudimentary hardware configurations

	Axially polarized magnet (linear movement or magnet presence detection)
Hall-effect push switch	
Smart cover	
	Bar magnet (linear movement and magnet field detection)
Slide switch	A MARTING





## 3.4 Software configuration

#### 3.4.1 Registers to configure for Hall-effect sensing:

#### Table 3.2 Hall-effect sensing settings registers

Address	Name	Description	Recommended setting
	Hall-effect settings 0	Charge frequency divider and	Charge frequency adjusts the
		ATI mode settings	conversion rate of the Hall-effect
			channels. Faster conversions
0x90			consume less current.
			Full ATI is recommended for fully
			automated sensor tuning.
	Hall-effect settings 1	ATI base and target	ATI target should be more than
0x91		selections	ATI base to achieve an ATI
	Hall-effect switch UI	Various settings for the Hall-	None
0xA0	settings	effect switch UI	
	Hall-effect switch UI	Proximity Threshold for UI	Less than touch threshold
0xA1	proximity threshold		
	Hall-effect switch UI	Touch Threshold for UI	None
0xA2	touch threshold		

#### 3.4.2 Example code:

Example code for an Arduino Uno can be downloaded at:

www.azoteq.com//images/stories/software/IQS62x Demo.zip





# 3.5 Sensor data output and flags

The following registers can be monitored by the master to detect Hall-effect related events.

a) One bit in the **Global events (0x11)** register is dedicated to the Hall-effect output. Bit2 HALL\_EVENT will be toggled for any Hall-effect UI detections.

	Global events (0x11)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R	R	R	R	R	R	R	R				
Name	SAR ACTIVE	PMU EVENT	SYS EVENT	TEMP EVENT	HYSTE- RESIS UI EVENT	HALL EVENT	SAR EVENT	PROX SENSE EVENT				

b) The Hall-effect UI flags (0x16) register provides the standard two-level activation output (prox = HALL\_POUT & touch = HALL\_TOUT) as well as a HALL\_N/S bit to indicate the magnet polarity orientation.

	Hall-effect UI flags (0x16)											
Bit Number												
Data Access	-	-	-	-	-	R	R	R				
Name	-	-	-	-	-	HALL TOUT	HALL POUT	HALL N/S				

c) The **Hall-effect UI output (0x17 & 0x18)** registers provide a 16-bit value of the Hall-effect amplitude detected by the sensor.

	Hall-effect UI Output (0x17 - 0x18)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R	R R R R R R R R									
Name			Hall	-effect UI o	utput low	byte					
Bit Number	15	14	13	12	11	10	9	8			
Data Access	R	R R R R R R R									
Name			Hall-	effect UI o	utput high	byte					



# 4 Inductive sensing

#### 4.1 Introduction to inductive sensing

The IQS620A provides inductive sensing capabilities in order to detect the presence of metal/metal-type objects. Prox and touch thresholds are widely adjustable and individual hysteresis settings are definable for each using the Hysteresis UI.

## 4.2 Channel specifications

The IQS620A requires both Rx sensing pins as well as the Tx pin for inductive sensing.

Channels 0, 1 and/or 2 can be setup for inductive sensing although only channel 2 can be used for the Hysteresis UI which is attractive as an inductive data processing UI.

The Hysteresis UI provides superior options for prox and touch activation with filter halt and hysteresis settings.

a) Hysteresis UI (Dedicated to CH2)

Table 4.1Inductive sensor – channel allocation	ation
--	-------

Mode	CH0	CH1	CH2	CH3	CH4	CH5
Inductive resonant tank	0	0	0			
Inductive mutually coupled coils	0	0	0			
Hysteresis UI			•			

Key:

O - Optional implementation

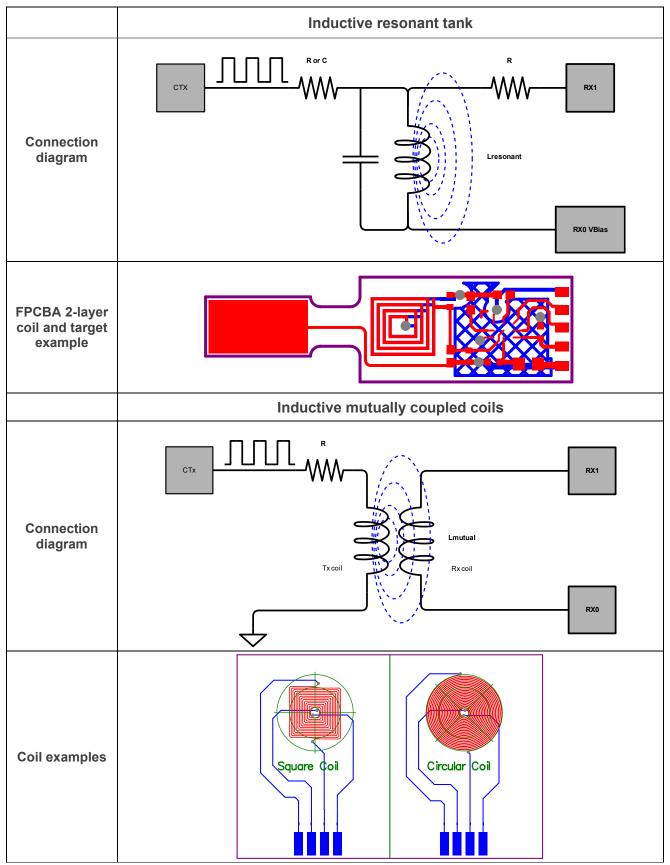
• - Fixed use for UI



# 4.3 Hardware configuration

Rudimentary hardware configuration. Please refer to application note <u>AZD115</u> for design details.









#### 4.4 Software configuration

#### 4.4.1 Registers to configure for inductive sensing:

Please note: If the discreet button UI is used then the SAR UI cannot be used, and the SAR registers should not be configured or used. Initializing inactive UI registers can corrupt other active UI's.

Address	Name	Description	Recommended setting
	ProxFusion Settings 0	ProxFusion Settings 0 Sensor mode and	
		configuration of channel 2.	inductive mode
0x42			Both RX0 and RX1 should be
			active on channel 2
	ProxFusion Settings 1	Channel 2 settings for the	Full ATI is recommended for fully
0x45		inductive sensor	automated sensor tuning.
	ProxFusion Settings 2	ATI settings for the inductive	ATI target should be more than
0x48		sensor	ATI base to achieve an ATI
	ProxFusion Settings 3	Additional settings for the	None
0x4B		inductive sensor	
	ProxFusion Settings 4	UI enable command and filter	Enable the Hysteresis UI filter
0x50		settings	according to application

#### Table 4.3Inductive sensing settings registers

#### 4.4.2 Registers to configure for the Hysteresis UI:

Please note: Only channel 2 can be used with the Hysteresis UI. Please setup channel 2 accordingly if required. The Hysteresis UI can be used simultaneously with the discrete button UI or SAR UI.

#### Table 4.4Hysteresis UI settings registers

Address	Name	Description
0x50	ProxFusion settings 4	Hysteresis UI enable command
0x80	Hysteresis UI Settings	Hysteresis settings for the Hysteresis UI prox and touch output
0x81	Hysteresis UI filter halt threshold	Threshold setting to trigger a filter halt for sensor data on channel 2
0x82	Hysteresis UI proximity threshold	Proximity threshold used for sensor data on channel 2
0x83	Hysteresis UI touch threshold	Touch threshold used for sensor data on channel 2





# 4.5 Sensor data output and flags

The following registers can be monitored by the master to detect inductive sensor related events.

- a) Global events (0x11) to prompt for inductive sensor activation. Bit0 PROXSENSE\_EVENT will indicate the detection of a metal object on any of the channels 0, 1 or 2 using the discreet mutual inductive sensing UI permitted that the specific channel is setup for inductive sensing.
- b) Bit3 denoted as HYSTERESIS\_UI\_EVENT will indicate the detection of a metal object using the hysteresis UI on an inductive sensing channel permitted that the hysteresis UI is activated.

	Global events (0x11)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R	R	R	R	R	R	R	R			
Name	SAR ACTIVE	PMU EVENT	SYS EVENT	TEMP EVENT	HYSTE- RESIS UI EVENT	HALL EVENT	SAR EVENT	PROX SENSE EVENT			

c) The **Hysteresis UI flags (0x13)** register provides the classic prox/touch two level activation outputs as well as a bit to distinguish whether the current counts are above or below the LTA.

	Hysteresis UI flags (0x13)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R	R	R	-	-	-	-	-			
Name	Signed output	тоисн	PROX	-	-	-	-	-			

d) **Hysteresis UI output (0x14 & 0x15)** registers will provide a combined 16-bit value to acquire the magnitude of the inductive sensed object.

	Hysteresis UI output (0x14 - 0x15)										
Bit Number	7	7 6 5 4 3 2 1 0									
Data Access	R	R	R	R	R	R	R	R			
Name			Hyst	teresis UI o	output low	byte	·				
Bit Number	15	14	13	12	11	10	9	8			
Data Access	R	R R R R R R R									
Name	Hysteresis UI output high byte										





#### 5 Temperature monitoring

#### 5.1 Introduction to temperature monitoring

The IQS620A provides temperature monitoring capabilities which can be used for temperature change detection in order to ensure the integrity of other sensing technology. The use of the temperature sensor is primarily to reseed other sensor channels to account for sudden changes in environmental conditions.

The IQS620A uses a linearly proportional to absolute temperature sensor for temperature data. The temperature output data is given by,

$$T = \frac{a.2^{19}}{b.CH_3} + c$$

Where a, b and c are constants that can be determined to provide a required output data as a function of device temperature. Additionally, the channel setup must be calculated during a testing process.

The IQS620AT part(s) have been calibrated during production and will use OTP stored values calculated for that specific part for parameters a, b and c as well as a 4-bit value used for the fine multiplier setup of channel 3 (default always uses the lowest course multiplier).

Parameter			IQS620		IQS620A		
Name	Description	ŀ	Register	Range	Register	Range	
а	Multiplier	0x02	Higher nibble	1 – 16	0xC2	1 – 256	
b	Divider	0xC2	Lower nibble	1 – 16	0xC3	1 – 256	
С	Offset	0xC3		0 – 255	0xC4	0 – 255	

 Table 5.1
 Temperature calibration setting registers and ranges

#### 5.2 Channel specifications

The IQS620A requires only external passive components to do temperature monitoring (no additional circuitry/components required). The temperature UI will be executed using data from channel 3.

#### Table 5.2 Temperature sensor – channel allocation

Mode	CH0	CH1	CH2	CH3	CH4	CH5
Temperature monitoring				٠		

Key:

O - Optional implementation

• - Fixed use for UI

Please note that channels 4 and 5, for Hall-effect sensing, needs to be active in order for the temperature monitoring UI to execute correctly on version 0 and 1 software versions.

For version 2 & 3 devices Hall-effect channels 4 & 5 may be disabled regardless.

#### 5.3 Hardware configuration

No additional hardware required. Temperature monitoring is realized on-chip.





# 5.4 Software configuration

# 5.4.1 Registers to configure for temperature monitoring For IQS620 only:

#### Table 5.3

# 5.3 *Temperature monitoring settings registers*

Address	Name	Description	Recommended setting
0xC0	Temperature UI settings	Channel reseed settings	Reseed enable should be set
0xC1	Multipliers channel 3	Temperature sensor channel multiplier selection	Dependent on calibration step
0xC2	Temperature calibration data 0	4-bit Multiplier $(a+1)$ and 4-bit divider $(b+1)$ calibration values	Requires sample calibration
0xC3	Temperature calibration data 1	8-bit Offset ( <i>c</i> ) calibration value	Requires sample calibration

# For IQS620AX:

# Table 5.4Temperature monitoring settings registers

Address	Name	Description	Recommended setting
0xC0	Temperature UI settings	Channel reseed settings	Reseed enable should be set
0xC1	Multipliers channel 3	Temperature sensor channel multiplier selection	Dependent on calibration step Defined during fabrication for IQS620AT samples
0xC2	Temperature UI calibration multiplier	8-bit Multiplier ( <i>a</i> +1) calibration value	Requires sample calibration Defined during fabrication for IQS620AT samples
0xC3	Temperature calibration UI divider	8-bit Divider ( <i>b</i> +1) calibration value	Requires sample calibration Defined during fabrication for IQS620AT samples
0xC4	Temperature UI offset	8-bit Offset ( <i>c</i> ) calibration value	Requires sample calibration Defined during fabrication for IQS620AT samples





# 5.5 Sensor data output and flags

The following registers can be monitored by the master to detect temperature related events.

e) **Global events (0x11)** to prompt for temperature trip activation. Bit4 denoted as TEMP\_EVENT will indicate the detection of a temperature event.

	Global events (0x11)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R	R	R	R	R	R	R	R			
Name	SAR ACTIVE	PMU EVENT	SYS EVENT	TEMP EVENT	HYSTE- RESIS UI EVENT	HALL EVENT	SAR EVENT	PROX SENSE EVENT			

f) The **Temperature UI flags (0x19)** register provides a temperature trip activation output bit if the condition of a temperature reseed threshold is tripped.

	Temperature UI flags (0x19)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R	-	-	-	-	-	-	-				
Name	Temp trip	-	-	-	-	-	-	-				

g) Temperature UI output (0x1A & 0x1B) registers will provide a combined (big-endian) 16bit output value for the measured internal IC temperature. Please note:

- For the IQS620AT part(s) (Device version 1 & 2: HW number 0x02 = 0x82):
  - The calibration was done so that the UI output is offset by a decimal value of **+100** in order to be able to calculate and represent absolute temperatures below 0°C in the controller arithmetic and temperature UI capabilities.
  - Example: Temperature UI output = 120'D → 20°C or 90'D → -10°C
- For the IQS620AT part(s) (Device version 3: HW number 0x02 = **0x92**):
  - The calibration was done so that the UI output is offset by a decimal value of **+40** in order to be able to calculate and represent absolute temperatures below 0°C in the controller arithmetic and temperature UI capabilities.

		Те	mperature	UI output (	0x1A – 0x <sup>2</sup>	1B)		
Bit Number	7	6	5	4	3	2	1	0
Data Access	R	R	R	R	R	R	R	R
Name			Tem	nperature o	output low	byte		
Bit Number	15	14	13	12	11	10	9	8
Data Access	R	R	R	R	R	R	R	R
Name			Tem	perature o	utput high	byte		

◦ Example: Temperature UI output =  $60^{\circ}D \rightarrow 20^{\circ}C$  or  $30^{\circ}D \rightarrow -10^{\circ}C$ 





#### 6 Device clock, power management and mode operation

#### 6.1 Device main oscillator

The IQS620A has a **16MHz** main oscillator (default enabled) to clock all system functionality.

An option exists to reduce the main oscillator to 4MHz. This will result in charge transfer frequencies to be one-quarter of the default implementations. System timers are adjusted so that timeouts and report rates remain the same if possible.

To set this option this:

- As a software setting Set the System Settings: bit4 = 1, via an  $I^2C$  command.
- As a permanent setting Set the OTP option in OTP Bank 0: bit2 = 1, using IQS620A PC software.

#### 6.2 Device modes

The IQS620A supports the following modes of operation;

- Normal mode (Fixed report rate)
- Low power mode (Reduced report rate)
- **Ultra-low power mode** (Only channel 0 is sensed for a prox)
- Halt mode (Suspended/disabled) Note: Auto modes must be disabled to enter or exit halt mode.

The device will automatically switch between the different operating modes by default. However, this Auto mode feature may be disabled by setting the DSBL\_AUTO\_MODE bit (Power\_mode\_settings 0xD2: bit5) to confine device operation to a specific power mode. The POWER\_MODE bits (Power\_mode\_settings 0xD2: bit4-3) can then be used to specify the desired mode of operation.

#### 6.2.1 Normal mode

Normal mode is the fully active sensing mode to function at a fixed report rate specified in the Normal mode report rate (0xD3) register. This 8-bit value is adjustable from 0ms - 255ms in intervals of 1ms.

Note: The device's low power oscillator has an accuracy of 4ms.

#### 6.2.2 Low power mode

Low power mode is a reduced sensing mode where all channels are sensed but at a reduced oscillator speed. The sample rate can be specified in the Low Power mode report rate (0xD4) register. The 8-bit value is adjustable from 0ms - 255ms in intervals of 1ms. Reduced report rates also reduce the current consumed by the sensor.

Note: The device's low power oscillator has an accuracy of 4ms.

#### 6.2.3 Ultra-low power mode

Ultra-low power mode is a reduced sensing mode where only channel 0 is sensed at the ultra low power report rate. Channels 1 to 5 are only updated (sensed and processed according to each channels setup) during a normal power update cycle. This NP update cycle rate can be set as a fraction of the configured ULP mode report rate. There are 8 NP segment fraction options available (Power\_mode\_settings: bit2-0) ranging from the fastest, ½ ULP rate to the slowest rate of 1/256 of the ULP rate. This ensures that channels 1 to 5's LTA values track any slow changes in sensor counts (typically seen over a long period for varying environmental conditions).

To enable use of the ultra-low power mode set the EN\_ULP\_MODE bit (Power\_mode\_settings: bit6). The sample rate can be specified in the Ultra-Low Power mode report rate (0xD5) register. The 8-bit value is adjustable from 0ms – 4sec in increments of 16ms for each decimal integer.

IQS620A wake up (return to normal mode) will occur on prox detection of channel 0.





#### 6.2.4 Halt mode

Halt mode will suspend all sensing and will place the device in a dormant or sleep state. The device requires an I<sup>2</sup>C command from a master to explicitly change the power mode out of the halt state before any sensor functionality can continue.

#### 6.2.5 Mode time

The mode time defines the time period in normal or low power modes before automatically moving to a slower mode (or finally ULP mode if applicable) if no activations are registered in this time. This time is set in the Auto Mode Timer (0xD6) register. The 8-bit value is adjustable from 0ms - 2 min in intervals of 500ms.

#### 6.3 System reset

The IQS620A device monitor's system resets and events.

- a) Every device power-on and reset event will set the Show Reset bit (System flags 0x10: bit7) and the master should explicitly clear this bit by setting the ACK\_RESET (bit6) in System Settings.
- b) The system events will also be indicated with the Global events register's SYS\_EVENT bit (Global events 0x11: bit5) if any system event occur such as a reset. This event will continuously trigger until the reset has been acknowledged.





# 7 Communication

#### 7.1 I<sup>2</sup>C module specification

The device supports a standard two wire I<sup>2</sup>C interface with the addition of an RDY (ready interrupt) line. The communications interface of the IQS620A supports the following:

- Standard-mode I<sup>2</sup>C protocol compliant for speed up to 100kbits/s.
- Faster speeds possible up to 400kbits/s but without *Fast-mode* minimum fall time fulfilment.
- Streaming data as well as event mode.
- The master may address the device at any time. If the IQS620A is not in a communication window, the device will return an ACK after which clock stretching may be induced until a communication window is entered. Additional communication checks are included in the main loop in order to reduce the average clock stretching time.
- The provided interrupt line (RDY) is an open-drain active low implementation and indicates a communication window.

# 7.2 I<sup>2</sup>C Read

To read from the device a *current address read* can be performed. This assumes that the addresscommand is already setup as desired.

#### Current Address Read

Start	Control byte		Data n		Data n+1		Stop
S	Addr + READ	ACK		ACK		NACK	S

Figure 7.1 Current Address Read

If the address-command must first be specified, then a *random read* must be performed. In this case, a WRITE is initially performed to setup the address-command, and then a repeated start is used to initiate the READ section.

#### Random Read

Start	Control byte		Address- command		Start	Control byte		Data n		Stop
S	Addr + WRITE	ACK		ACK	s	Addr + READ	ACK		NACK	S

Figure 7.2 *Random Read* 

#### 7.3 I<sup>2</sup>C Write

To write settings to the device a *Data Write* is performed. Here the Address-Command is always required, followed by the relevant data bytes to write to the device.

				Data V	<u>Vrite</u>				
Start	Control byte		Address- Command		Data n		Data n+1		Stop
S	Addr + WRITE	ACK		ACK		ACK		ACK	S
	•								

# Figure 7.3 *I<sup>2</sup>C Data Write*





# 7.4 Stop-bit disable option

The IQS620A parts offer:

- an additional <u>I<sup>2</sup>C settings</u> register (0xDA) specifically added for stop-bit disable functionality,
- as well as a <u>RDY timeout period</u> register (0xD9) in order to set the required timeout period for termination of any communication windows (RDY = Low) if no I<sup>2</sup>C activity is present on SDA and SCL pins.

Customers using an MCU with a binary serial-encoder peripheral which is not fully I<sup>2</sup>C compatible (but provide some crude serial communication functions) can use this option to configure the IQS620A so that any auto generated stop command from the serial peripheral can be ignored by the IQS620A I<sup>2</sup>C hardware. This will restrict the IQS620A from immediately exiting a communication window until all required communication has been completed and a stop command can correctly be transmitted. Please refer to the figures below for serial data transmission examples.

Please note:

- 1. Stop-bit disable and enable must be performed at the beginning and end of a communication window. The first and last I<sup>2</sup>C register to be written to ensure no unwanted communication window termination.
- 2. Leaving the Stop-bit disabled will result in successful reading of registers but will not execute any commands written over I2C in a communication window being terminated after an RDY timeout and with no IQS recognised stop command.
- 3. The default RDY timeout period for IQS620A is purposefully long (10.24ms) for slow responding MCU hardware architectures. Please set this register according to your requirements/preference.
- 4. These options are only available on IQS620A parts and not for IQS620.

Communication window open	Start	Control byte		Address- Command		Disable stop-bit		lgnored stop	Continue with reads / writes
RDY = ↓LOW	S	Addr + WRITE	ACK	0xDA	ACK	0x81	ACK	S	

#### Stop-bit Disable

# Figure 7.4 *I*<sup>2</sup>*C Stop-bit Disable*

Reads / Writes Finished	Start	Control byte		Address- Command		Enable stop-bit		Stop	Communication window closed
	S	Addr + WRITE	ACK	0xDA	ACK	0x01	ACK	S	RDY = ↑HIGH

Figure 7.5 *I*<sup>2</sup>*C Stop-bit Enable* 





#### 7.5 Device address and sub-addresses

#### The default device address is **0x44 = DEFAULT\_ADDR**.

Alternative sub-address options are definable in the following one-time programmable bits: **OTP Bank0 (bit3; 0; bit1; bit0) = SUB\_ADDR\_0** to **SUB\_ADDR\_7** 

a)	Default address:	0x44 = DEFAULT_ADDR (0x44)	OR	SUB_ADDR_0 ( <b>0000b</b> )
b)	Sub-address:	0x45 = DEFAULT_ADDR (0x44)	OR	SUB_ADDR_1 ( <b>0001b</b> )
c)	Sub-address:	0x46 = DEFAULT_ADDR (0x44)	OR	SUB_ADDR_2 ( <b>0010b</b> )
d)	Sub-address:	0x47 = DEFAULT_ADDR (0x44)	OR	SUB_ADDR_3 ( <b>0011b</b> )
e)	Sub-address:	0x4C = DEFAULT_ADDR (0x44)	OR	SUB_ADDR_4 ( <b>1000b</b> )
f)	Sub-address:	0x4D = DEFAULT_ADDR (0x44)	OR	SUB_ADDR_5 ( <b>1001b</b> )
g)	Sub-address:	0x4E = DEFAULT_ADDR (0x44)	OR	SUB_ADDR_6 ( <b>1010b</b> )
h)	Sub-address:	<b>0x4F</b> = DEFAULT_ADDR ( <b>0x44</b> )	OR	SUB_ADDR_7 (1011b)

# 7.6 Additional OTP options

#### 7.6.1 Device version 0 (Software number 0x04 = D'04)

All one-time-programmable device options are located in OTP bank0.

	OTP bank0												
Bit Number	7	6	5	4	3	2	1	0					
Name	Internal use	COMMS ATI	Internal use	Internal use	SUB ADDRESS (bit3)	4MHz	SUB ADDR	ESS (bit1-0)					

Bit definitions:

- Bit 7: Internal use
  - $\circ$   $\,$  Do not set. Leave bit cleared.
- Bit 6: Communication mode during ATI
  - o 0: No streaming events are generated during ATI
  - 1: Communication continue as setup regardless of ATI state.
- Bit 5,4: Internal use
  - o Do not configure
- Bit 2: Main Clock frequency selection
  - o 0: Run FOSC at 16MHz
  - 1: Run FOSC at 4MHz
- Bit 3,1,0: I<sup>2</sup>C sub-address
  - I<sup>2</sup>C address = 0x44 OR SUB\_ADDR





#### 7.6.2 Device version 1 (Software number 0x08 = D'08)

All one-time-programmable device options are located in OTP bank0.

	OTP bank0											
Bit Number	7	6	5	4	3	2	1	0				
Name	Internal use	COMMS ATI	Internal use	Internal use	SUB ADDRESS (bit3)	4MHz	SUB ADDR	ESS (bit1-0)				

Bit definitions:

- Bit 7: Internal use
  - $\circ$   $\,$  Do not set. Leave bit cleared.
- Bit 6: Communication mode during ATI
  - 0: No streaming events are generated during ATI
  - 1: Communication continue as setup regardless of ATI state.
- Bit 5,4: Internal use
  - o Do not configure
- Bit 2: Main Clock frequency selection
  - o 0: Run FOSC at 16MHz
  - 1: Run FOSC at 4MHz
- Bit 3,1,0: I<sup>2</sup>C sub-address
  - $\circ$  I<sup>2</sup>C address = 0x44 OR SUB\_ADDR

#### 7.6.3 Device version 2 & 3 (Software number 0x0D = D'13)

All one-time-programmable device options are located in OTP bank0.

	OTP bank0											
Bit Number	7	6	5	4	3	2	1	0				
Name	Disable Hall	COMMS ATI	Internal use	Internal use	SUB ADDRESS (bit3)	4MHz	SUB ADDR	ESS (bit1-0)				

Bit definitions:

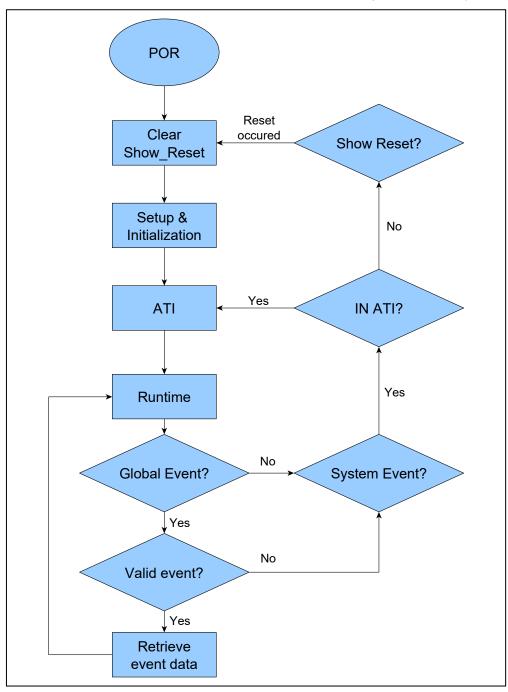
- Bit 7: Disable Hall
  - 0: All sensors are active.
  - 1: Hall-effect sensors are disabled permanently. Use this option for 1.8V rated supplies requiring up to 5% tolerance (absolute minimum  $V_{DDHI} >= 1.71V$ ).
- Bit 6: Communication mode during ATI
  - o 0: No streaming events are generated during ATI
  - 1: Communication continue as setup regardless of ATI state.
- Bit 5,4: Internal use
  - Do not configure
- Bit 2: Main Clock frequency selection
  - o 0: Run FOSC at 16MHz
  - 1: Run FOSC at 4MHz
- Bit 3,1,0: I<sup>2</sup>C sub-address
  - I<sup>2</sup>C address = 0x44 OR SUB\_ADDR





# 7.7 Recommended communication and runtime flow diagram

The following is a basic master program flow diagram to communicate and handle the device. It addresses possible device events such as output events, ATI and system events (resets).



## Figure 7.6 Master command structure and runtime event handling flow diagram

It is recommended that the master verifies the status of the System\_Flags0 bits to identify events and resets. Detecting either one of these should prompt the master to the next steps of handling the IQS620A.

Streaming mode communication is used for detail sensor evaluation during prototyping and/or development phases.

Event mode communication is recommended for runtime use of the IQS620A. This reduces the communication on the  $I^2C$  bus and report only triggered events.



IQ Switch® ProxFusion® Series



#### 8 Memory map

Table 8.1IQS620A Memory map index

Full Address	Group Name	Item Name	Data Access
0x00		Product number	Read-Only
0x01	Device information data	Software number	Read-Only
0x02		Hardware number	Read-Only
0x10		System flags	Read-Only
0x11		Global events	Read-Only
0x12		ProxFusion UI flags	Read-Only
0x13		SAR and Hysteresis UI flags	Read-Only
0x14		<u>Hysteresis UI output 0</u>	Read-Only
0x15	Flags and user interface data	<u>Hysteresis UI output 1</u>	Read-Only
0x16	Flags and user interface data	Hall-effect UI flags	Read-Only
0x17		Hall-effect UI output 0	Read-Only
0x18		Hall-effect UI output 1	Read-Only
0x19		Temperature UI flags	Read-Only
0x1A		Temperature UI output 0	Read-Only
0x1B		Temperature UI output 1	Read-Only
0x20		Channel 0 counts low	Read-Only
0x21		Channel 0 counts high	Read-Only
0x22		Channel 1 counts low	Read-Only
0x23		Channel 1 counts high	Read-Only
0x24		Channel 2 counts low	Read-Only
0x25	Channel counts (row data)	Channel 2 counts high	Read-Only
0x26	<u>Channel counts (raw data)</u>	Channel 3 counts low	Read-Only
0x27		Channel 3 counts high	Read-Only
0x28		Channel 4 counts low	Read-Only
0x29		Channel 4 counts high	Read-Only
0x2A		Channel 5 counts low	Read-Only
0x2B		Channel 5 counts high	Read-Only
0x30		Channel 0 LTA low	Read-Write
0x31	LTA values (filtered data)	Channel 0 LTA high	Read-Write
0x32		Channel 1 LTA low	Read-Write
0x33		Channel 1 LTA high	Read-Write
0x34		Channel 2 LTA low	Read-Write
0x35		Channel 2 LTA high	Read-Write





0x40		ProxFusion settings 0_0	Read-Write
0x41		ProxFusion settings 0_1	Read-Write
0x42		ProxFusion settings 0_2	Read-Write
0x43		ProxFusion settings 1_0	Read-Write
0x44		ProxFusion settings 1_1	Read-Write
0x45	ProxFusion sensor settings	ProxFusion settings 1_2	Read-Write
0x46	block 0	ProxFusion settings 2_0	Read-Write
0x47		ProxFusion settings 2_1	Read-Write
0x48		ProxFusion settings 2_2	Read-Write
0x49		ProxFusion settings 3_0	Read-Write
0x4A		ProxFusion settings 3_1	Read-Write
0x4B		ProxFusion settings 3_2	Read-Write
0x50		ProxFusion settings 4	Read-Write
0x51		ProxFusion settings 5	Read-Write
0x52		Compensation Ch0	Read-Write
0x53	ProxFusion sensor settings	Compensation Ch1	Read-Write
0x54	block 1	Compensation Ch2	Read-Write
0x55		Multipliers Ch0	Read-Write
0x56		Multipliers Ch1	Read-Write
0x57		Multipliers Ch2	Read-Write
0x60		Prox threshold Ch0	Read-Write
0x61		Touch threshold Ch0	Read-Write
0x62		Prox threshold Ch1	Read-Write
0x63	ProxFusion UI settings	Touch threshold Ch1	Read-Write
0x64		Prox threshold Ch2	Read-Write
0x65		Touch threshold Ch2	Read-Write
0x66		ProxFusion discrete UI halt time	Read-Write
0x70		SAR UI settings 0	Read-Write
0x71		SAR UI settings 1	Read-Write
0x72	SAR UI settings	QRD threshold Ch0	Read-Write
0x73	Unit UI settings	Filter halt threshold Ch0	Read-Write
0x74		Prox threshold Ch0	Read-Write
0x75		Quick release detection halt time	Read-Write
0x80		Hysteresis UI settings	Read-Write
0x81	Hysteresis UI settings	Hysteresis UI filter halt threshold	Read-Write
0x82	Tysicresis Of settings	Hysteresis UI prox threshold	Read-Write
0x83		Hysteresis UI touch threshold	Read-Write





0x90Hall-effect settings 0Read-Write0x91Hall-effect settings 1Read-Write0x92Compensation Ch4 and Ch5Read-Write0x93Multipliers Ch4 and Ch5Read-Write0xA0Hall-effect switch UI settingsRead-Write0xA1Hall-effect switch UI settingsRead-Write0xA2Hall-effect switch UI prox thresholdRead-Write0xC1Temperature UI settingsRead-Write0xC2Temperature UI settingsRead-Write0xC3Temperature UI settingsRead-Write0xC4Temperature calibration data1Tempe calibration divider*0xD1System settingsRead-Write0xD3Device and power mode settingsSystem settingsRead-Write0xD4Device and power mode settingsUltra-low power mode report rateRead-Write0xD4Clobal event maskRead-WriteNormal mode report rateRead-Write0xD4System settingsAuto mode timeRead-WriteMultipliers*Read-Write0xD4Device and power mode settingsAuto mode timeRead-WriteMultipliers*Read-Write0xD4Device and power mode settingsMultipliers*Read-WriteRead-WriteRead-Write0xD5Device and power mode settingsAuto mode timeRead-WriteRead-WriteRead-Write0xD6SettingsAuto mode timeRead-WriteRead-WriteRead-WriteRead-Write0xD6SettingsAuto mode timeR					
Mail-effect sensor settings         Compensation Ch4 and Ch5         Read-Write           0x93         Multipliers Ch4 and Ch5         Read-Write           0xA0         Hall-effect switch UI settings         Read-Write           0xA1         Hall-effect switch UI settings         Read-Write           0xA2         Hall-effect switch UI prox threshold         Read-Write           0xC0         Image: Settings         Read-Write         Hall-effect switch UI prox threshold         Read-Write           0xC1         Image: Settings         Temperature UI settings         Read-Write         Multipliers Ch3         Read-Write           0xC2         Image: Settings         Temp calibration data1         Temp calibration divider*         Read-Write           0xC4         System settings         Read-Write         Read-Write         Read-Write           0xD1         System settings         Read-Write         Read-Write         Read-Write           0xD2         Device and power mode settings         Read-Write         Normal mode report rate         Read-Write           0xD4         Settings         Auto mode time         Read-Write         Submate           0xD4         Device and power mode settings         Read-Write         Submate         Read-Write           0xD4         Dev	0x90		Hall-effect	<u>settings 0</u>	Read-Write
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OxA0         Hall-effect switch UI settings         Read-Write           0xA1         Hall-effect switch UI settings         Read-Write           0xA2         Hall-effect switch UI prox threshold         Read-Write           0xA2         Hall-effect switch UI touch threshold         Read-Write           0xC0         Image: state s	0x92	Hail-effect sensor settings	<u>Compensation</u>	Ch4 and Ch5	Read-Write
OxA1         Hall-effect switch UI settings         Hall-effect switch UI prox threshold         Read-Write           0xA2         Hall-effect switch UI touch threshold         Read-Write           0xC0         Image: settings         Read-Write           0xC1         Image: settings         Read-Write           0xC2         Image: settings         Read-Write           0xC3         Image: settings         Read-Write           0xC4         Image: settings         Read-Write           0xC4         Image: settings         Read-Write           0xD0         Image: settings         Read-Write           0xD1         System settings         Read-Write           0xD2         Image: settings         Read-Write           0xD4         Image: settings         Read-Write           0xD5         Device and power mode         System settings         Read-Write           0xD4         Image: settings         Read-Write         Read-Write           0xD6         Settings         Read-Write         Read-Write           0xD4         Image: settings         Read-Write         Read-Write           0xD6         Settings         Read-Write         Read-Write           0xD6         Settings         Auto mode tim	0x93		Multipliers C	Ch4 and Ch5	Read-Write
OxA2         Hall-effect switch UI touch threshold         Read-Write           0xC0          Temperature UI settings         Read-Write           0xC1          Multipliers Ch3         Read-Write           0xC2         Temperature UI settings         Read-Write         Read-Write           0xC3         Temperature UI settings         Read-Write         Read-Write           0xC4         Temp calibration data1         Temp calibration divider         Read-Write           0xD0         System settings         Read-Write         Read-Write           0xD1         System settings         Read-Write         Read-Write           0xD2         System settings         Read-Write         Read-Write           0xD3         Power mode settings         Read-Write         Read-Write           0xD4         Device and power mode settings         Read-Write         Read-Write           0xD5         Device and power mode settings         Read-Write         Read-Write           0xD4         Device and power mode settings         Read-Write         Read-Write           0xD4         Device and power mode settings         Read-Write         Read-Write           0xD5         Device and power mode settings         Read-Write         Read-Write </th <th>0xA0</th> <th></th> <th>Hall-effect swi</th> <th>tch UI settings</th> <th>Read-Write</th>	0xA0		Hall-effect swi	tch UI settings	Read-Write
OxC0Temperature UI settingsRead-Write0xC1Temperature UI settingsRead-Write0xC2Temperature UI settingsRead-Write0xC3Temp calibration data0Temp calibration multiplier*Read-Write0xC4Temp calibration data1Read-Write0xD0System settingsRead-Write0xD1System settingsRead-Write0xD2Active channelsRead-Write0xD3Device and power mode settingsNormal mode report rateRead-Write0xD4Device and power mode settingsUltra-low power mode report rateRead-Write0xD4System settingsRead-WriteRead-Write0xD5Device and power mode settingsAuto mode timeRead-Write0xD6SettingsAuto mode timeRead-Write0xD7SubsettingsRead-WriteRead-Write0xD8Auto mode timeRead-Write0xD9PWM duty cycleRead-Write0xD4IfC settings*Read-Write0xD5Read-WriteRead-Write0xD6SettingsRead-Write0xD7Read-WriteRead-Write0xD8IfC settings*Read-Write0xD9IfC settings*Read-Write0xD4IfC settings*Read-Write	0xA1	Hall-effect switch UI settings	Hall-effect switch	UI prox threshold	Read-Write
OxC1         Multipliers Ch3         Read-Write           0xC2         Temperature UI settings         Temp calibration data0         Temp calibration multiplier*         Read-Write           0xC3         Temp calibration data1         Temp calibration divider*         Read-Write           0xC4         Temperature calibration offset*         Read-Write           0xD0         System settings         Read-Write           0xD1         System settings         Read-Write           0xD2         Power mode settings         Read-Write           0xD4         Normal mode report rate         Read-Write           0xD5         Device and power mode settings         Read-Write           0xD6         settings         Auto mode time         Read-Write           0xD7         Global event mask         Read-Write           0xD8         PWM duty cycle         Read-Write           0xD9         I²C settings*         Read-Write	0xA2		Hall-effect switch	UI touch threshold	Read-Write
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0xD1Active channelsRead-Write0xD2Power mode settingsRead-Write0xD3Normal mode report rateRead-Write0xD4Device and power modeLow power mode report rateRead-Write0xD5Device and power modeUltra-low power mode report rateRead-Write0xD6SettingsAuto mode timeRead-Write0xD7Global event maskRead-Write0xD8PWM duty cycleRead-Write0xD4IPC settings*Read-Write	0xC4		Temperature ca	alibration offset*	Read-Write
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0xD3       Normal mode report rate       Read-Write         0xD4       Normal mode report rate       Read-Write         0xD5       Device and power mode       Ultra-low power mode report rate       Read-Write         0xD6       Settings       Auto mode time       Read-Write         0xD7       Global event mask       Read-Write         0xD8       PWM duty cycle       Read-Write         0xD9       NDA       IPC settings*       Read-Write	0xD1		Active c	hannels	Read-Write
0xD4Device and power mode settingsLow power mode report rateRead-Write0xD5Device and power mode settingsUltra-low power mode report rateRead-Write0xD6Auto mode timeRead-Write0xD7Global event maskRead-Write0xD8PWM duty cycleRead-Write0xD9Read-WriteRead-Write0xDAI²C settings*Read-Write	0xD2		Power mo	<u>de settings</u>	Read-Write
0xD5       Device and power mode settings       Ultra-low power mode report rate       Read-Write         0xD6       Settings       Auto mode time       Read-Write         0xD7       Global event mask       Read-Write         0xD8       PWM duty cycle       Read-Write         0xD9       Read-Write       Read-Write         0xDA       Image: settings       Read-Write	0xD3		Normal mod	<u>e report rate</u>	Read-Write
OxD6     Settings     Auto mode time     Read-Write       0xD7     Global event mask     Read-Write       0xD8     PWM duty cycle     Read-Write       0xD9     Read-Write     Read-Write       0xDA     IPC settings*     Read-Write	0xD4		Low power mo	ode report rate	Read-Write
OxD7     Global event mask     Read-Write       0xD8     PWM duty cycle     Read-Write       0xD9     Read-Write     Read-Write       0xDA     I2C settings*     Read-Write	0xD5	Device and power mode	Ultra-low power	mode report rate	Read-Write
0xD8     PWM duty cycle     Read-Write       0xD9     Read-Write     Read-Write       0xDA     I <sup>2</sup> C settings*     Read-Write	0xD6	<u>settings</u>	Auto mo	ode time	Read-Write
0xD9     RDY Timeout period*     Read-Write       0xDA     I <sup>2</sup> C settings*     Read-Write	0xD7		<u>Global ev</u>	<u>vent mask</u>	Read-Write
0xDA <u>I<sup>2</sup>C settings*</u> Read-Write	0xD8		PWM de	uty cycle	Read-Write
	0xD9		RDY Time	out period*	Read-Write
OxDB         Channel reseed enable*         Read-Write	0xDA		l <sup>2</sup> C se	ttings*	Read-Write
	0xDB		Channel res	eed enable*	Read-Write

\* Only available for IQS620A v1 & v2

The full memory map is summarized above. Registers are explained individually in the latter part of this section.





# 8.2 Device Information Data

## 8.2.1 Product number

	Product number (0x00)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R	R	R	R	R	R	R	R			
Name				Device Proc	luct Number						

Bit definitions:

• Bit 7-0: Device Product Number

0x41 = D'65: IQS620(A) product number (all versions)

## 8.2.2 Software number

	Software number (0x01)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R	R	R	R	R	R	R	R			
Name				Device Softw	vare Number	-					

Bit definitions:

• Bit 7-0: Device Software Number

- 0x04 = D'04: IQS620 version 0 firmware (pre-production)
- 0x08 = D'08: IQS620A version 1 firmware (production)
- 0x0D = D'13: IQS620A version 2 firmware (update)

## 8.2.3 Hardware number

	Hardware number (0x02)										
Bit Number	7	7 6 5 4 3 2 1 0									
Data Access	R	R	R	R	R	R	R	R			
Name		·	[	Device Hardy	vare Numbe	r					

- Bit 7-0: Device Hardware Number
  - 0x82 = D'130: IQS620 version 0 hardware number
  - o 0x82 = D'130: IQS620A version 1 & 2 hardware number
  - 0x92 = D'146: IQS620A version 3 hardware number





## 8.3 Flags and user interface data

## 8.3.1 System flags

	System flags (0x10)												
Bit Number	7	6	5	4	3	2	1	0					
Data Access	R	-	-	R	R	R	R	R					
Name	SHOW RESET	-	-	POWER	MODE	IN ATI	EVENT	NP SEG ACTIVE					

Bit definitions:

- Bit 7: Reset Indicator
  - 0: No reset event
  - 1: A device reset has occurred and needs to be acknowledged.
- Bit 4-3: Active power-mode indicator
  - o 00: Normal Mode
  - 01: Low Power Mode
- Bit 2: ATI busy indicator
  - o 0: No CH's are in ATI
- Bit 1: Global Event Indicator
  - o 0: No new event to service
  - 1: An event has occurred and should be serviced
- Bit 0: Normal power segment indicator
  - o 0: Not performing a normal power update
  - o 1: Busy performing a normal power update

## 8.3.2 Global events

•

	Global events (0x11)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R	R	R	R	R	R	R	R				
Name	SAR ACTIVE	PMU EVENT	SYS EVENT	TEMP EVENT	HYSTE- RESIS UI EVENT	HALL EVENT	SAR EVENT	PROX SENSE EVENT				

Bit definitions:

•

- Bit 7: SAR activation state
  - 0: SAR output inactive
- Bit 6: Power management unit event flag
  - o 0: No event to report
- Bit 5: System event flag
  - o 0: No event to report
  - Bit 4: Temperature event flag
    - 0: No event to report
    - o 1: A temperature event has occurred and should be handled
- Bit 4: Hysteresis UI event flag
  - o 0: No event to report
  - o 1: A hysteresis UI event has occurred and should be handled

- o 10: Ultra-Low Power Mode
- o 11: Halt Mode
- 1: One or more CH's are in ATI

- o 1: SAR output active
- o 1: A PMU event occurred
- o 1: A system event has occurred





# • Bit 2: Hall-effect event flag

- 0: No event to report
- 1: A Hall-effect event has occurred and should be handled
- Bit 1: Single channel SAR event flag
  - 0: No event to report
  - 1: A single channel SAR event has occurred and should be handled
- Bit 0: ProxSense event flag
  - o 0: No event to report
  - o 1: A capacitive event has occurred and should be handled

## 8.3.3 ProxFusion UI flags

	ProxFusion UI flags (0x12)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	-	R	R	R	-	R	R	R				
Name	-	CH2_T	CH1_T	CH0_T	-	CH2_P	CH1_P	CH0_P				

Bit definitions:

.

- Bit 6: Ch2 touch indicator
  - o 0: Delta below touch threshold
- Bit 5: Ch1 touch indicator
  - 0: Delta below touch threshold
- Bit 4: Ch0 touch indicator
  - o 0: Delta below touch threshold
- Bit 2: Ch2 proximity indicator
  - 0: Delta below prox threshold
  - Bit 1: Ch1 proximity indicator
    - 0: Delta below prox threshold
- Bit 0: Ch0 proximity indicator
  - 0: Delta below prox threshold

# 8.3.4 Single channel SAR UI flags

- o 1: Delta above touch threshold
- o 1: Delta above touch threshold
- o 1: Delta above touch threshold
- 1: Delta above prox threshold
- 1: Delta above prox threshold
- o 1: Delta above prox threshold

	Single channel SAR UI flags (0x13)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	-	-	-	R	-	R	R	R				
Name	-	-	-	SAR ACTIVE	-	QRD	MOVE- MENT	FHALT				

- Bit 4: SAR Standoff Active
  - 0: Delta below SAR prox THR
- Bit 2: Quick Release Detection (QRD) indicator
  - o 0: Quick release not detected
- Bit 1: Movement indicator
  - 0: Movement not detected
- Bit 0: Filter Halt indicator

- $\circ$  1: Delta above SAR prox THR
- o 1: Quick release detected
- o 1: Movement detected





0: Delta below filter halt THR

1: Delta above filter halt THR

#### 8.3.5 Hysteresis UI flags

	Hysteresis UI flags (0x13)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R	R	R	-	-	-	-	-				
Name	Signed output	TOUCH	PROX	-	-	-	-	-				

Bit definitions:

•

- Bit 7: Delta directional signed output
  - 0: Counts < LTA. Delta positive
- Bit 6: Hysteresis UI touch indicator
  - 0: Delta below touch threshold
  - Bit 5: Hysteresis proximity indicator
    - o 0: Delta below prox threshold

#### 8.3.6 Hysteresis UI output

- 1: Counts > LTA. Delta negative
- o 1: Delta above touch threshold
- 1: Delta above prox threshold

	Hysteresis UI output (0x14 - 0x15)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R	R	R	R	R	R	R	R			
Name			Hys	steresis UI O	utput Low By	/te					
Bit Number	15	14	13	12	11	10	9	8			
Data Access	R	R R R R R R R R									
Name			Hys	teresis UI O	utput High B	yte	•				

Bit definitions:

• Bit 15-0: Hysteresis UI output value





# 8.3.7 Hall-effect UI flags

	Hall-effect UI flags (0x16)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	-	-	-	-	-	R	R	R			
Name	-	-	-	-	-	TOUCH	PROX	HALL N/S			

Bit definitions:

- Bit 2: Hall-effect touch indicator
  - 0: Count delta below touch threshold
- Bit 1: Hall-effect proximity indicator
  - 0: Count delta below prox threshold
- Bit 0: Hall-effect North South Field indication
   O: North field direction present
  - 0: North field direction present

- 1: Count delta above touch threshold
- 1: Count delta above prox threshold
- 1: South field direction present

Please note: Only for IQS620AXz**CS**R (CS = WLCSP-9) a flip chip process is used thus:

- 0: South field direction present
- 1: North field direction present

## 8.3.8 Hall-effect UI output

	Hall-effect UI output (0x17/0x18)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R	R R R R R R R									
Name		Hall-effect UI Output Low Byte									
Bit Number	15	14	13	12	11	10	9	8			
Data Access	R	R R R R R R R R									
Name	Hall-effect UI Output High Byte										

Bit definitions:

• Bit 15-0: Hall-effect UI output

 $\circ$  0 – 8 000: Hall-effect UI output value





## 8.3.9 Temperature UI flags

	Temperature UI flags (0x19)									
Bit Number										
Data Access	R	-	-	-	-	-	-	-		
Name	Temp trip	-	-	-	-	-	-	-		

Bit definitions:

- Bit 7: Temperature trip indicator
  - 0: No event to report
  - 1: Temperature event occurred

## 8.3.10 Temperature UI output

	Temperature UI output (0x1A – 0x1B)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R	R R R R R R R									
Name		Temperature output low byte									
Bit Number	15	14	13	12	11	10	9	8			
Data Access	R	R R R R R R R									
Name	Temperature output high byte										

- Bit 15-0: Temperature UI output
  - IQS620A: Temperature output value (relative/unitless; uncalibrated)
  - IQS620AT (Device version 1 & 2: HW number 0x02 = 0x82):
    - Temperature output value -100 = Device die temperature (°C)
  - IQS620AT (Device version 3: HW number 0x02 = 0x92):
    - Temperature output value -40 = Device die temperature (°C)





# 8.4 Channel counts (raw data)

		Channel o	ounts Ch0	)/1/2/3 (0x2	0/0x21 - 0x	(2A/0x2B)					
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R	R R R R R R R									
Name		Channel Data Low Byte									
Bit Number	15	14	13	12	11	10	9	8			
Data Access	R	R R R R R R R									
Name	Channel Data High Byte										

Bit definitions:

• Bit 15-0: Channel counts

#### • AC filtered or raw value counts of ProxFusion sensor channels

## 8.5 LTA values (filtered data)

	LTA Ch0/1/2 (0x30/0x31 - 0x34/0x35)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R/W	/W R/W R/W R/W R/W R/W R/W									
Name		LTA Low Byte									
Bit Number	15	14	13	12	11	10	9	8			
Data Access	R/W	R/W R/W R/W R/W R/W R/W R/W									
Name		LTA High Byte									

Bit definitions:

• Bit 15-0: LTA filter value output

• Long term average value of channels





## 8.6 ProxFusion sensor settings block 0

# 8.6.1 **ProxFusion settings 0**

# Capacitive sensing

	ProxFusion settings 0_0/1/2 (0x40-0x42)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	-	-	-	-	R/W	R/W				
Name		ve sensor ode	Internal use	Internal use		_	RX Select					
Fixed value	0 0		-									

Bit definitions:

- Bit 7-6: Sensor Mode
  - o 00: Capacitive sensing mode
- Bit 1-0: RX Select
  - $\circ$  00: RX0 and RX1 is disabled
  - o 01: RX0 is enabled

#### • 10: RX1 is enabled

o 11: RX0 and RX1 is enabled

#### Inductive sensing

	ProxFusion settings 0_0/1/2 (0x40-0x42)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	-	R/W	-	-	R/W	R/W				
Name	Inductive sensor mode		Internal use	Multiplier range	- RX Select		elect					
Fixed value	1	0	-	-		-	1	1				

Bit definitions:

- Bit 7-6: Sensor Mode
  - 10: Inductive sensor mode
- Bit 4: Multiplier range
  - o 0: Large

o 1: Small

- Bit 1-0: RX Select
  - $\circ$  11: RX0 and RX1 is enabled (Fixed selection for inductive sensing)





## 8.6.2 ProxFusion settings 1

## Capacitive sensing

		Prox	Fusion set	tings 1_0/1	/2 (0x43 - 0	)x45)			
Bit Number	7	6	5	4	3	2	1	0	
Data Access	-	R/W	R/W	R/W	-	-	R/W	R/W	
Name	-	CSz	CHARG	E FREQ			AUTO A	I MODE	
Default	0x67								
Deidult	0	1	1	0	0	1	1	1	

Bit definitions:

- Bit 6: CS size
  - o 0: CS capacitor size is 15 pF
- Bit 5-4: Charge frequency divider .
  - o 00: 1/2
  - o 01: 1/4
- Bit 1-0: Auto ATI Mode •
  - o 00: ATI disabled
  - 01: Partial ATI (all multipliers are fixed)
  - 10: Semi-Partial ATI (only coarse multipliers are fixed) 0
  - 11: Full-ATI 0

#### Inductive sensing

	ProxFusion settings 1_0/1/2 (0x43 - 0x45)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	-	R/W	R/W	R/W	-	-	R/W	R/W				
Name	-	CSz	CHARG	E FREQ			AUTO AT	I MODE				
Default	0x67											
Delault	0	0 1 1 0 0 1 1 1										

Bit definitions:

.

- Bit 6: CS size
  - o 0: CS capacitor size is 15 pF
  - Bit 5-4: Charge frequency divider
    - o 00: 1/2
    - o 01: 1/4
- Bit 1-0: Auto ATI Mode
  - o 00: ATI disabled
  - o 01: Partial ATI (all multipliers are fixed)
  - 10: Semi-Partial ATI (only coarse multipliers are fixed) 0
  - 11: Full-ATI 0

- 1: CS capacitor size is 60 pF 0
- 10: 1/8 0
- 11: 1/16 0

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- 1: CS capacitor size is 60 pF 0
- 10: 1/8
- 11: 1/16
- - 0
  - 0





## 8.6.3 ProxFusion settings 2

# **Capacitive sensing**

		ProxF	usion sett	ings 2_0/1	/2 (0x46 - 0	x48)			
Bit Number	7	6	5	4	3	2	1	0	
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W	
Name	ATI_I	BASE			ATI_TAR	GET (x32)			
0xD0									
Delault	1	1 0 1 0 0 0							

Bit definitions:

- Bit 7-6: Auto ATI base value
  - o **00**: 75
    - o 01: 100

10: 150 0

11:200 0

- Bit 5-0: Auto ATI Target •
  - o ATI Target is 6-bit value x 32

## Inductive sensing

	ProxFusion settings 2_0/1/2 (0x46 - 0x48)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W			
Name	ATI_I	BASE			ATI_TAR	GET (x32)					
Default				0x	D0						
Deidult	1	1 1 0 1 0 0 0 0									

Bit definitions:

- Bit 7-6: Auto ATI base value •
  - o **00:75** 10: 150 0 o 01: 100
    - 11:200 0

Bit 5-0: Auto ATI Target •

o ATI Target is 6-bit value x 32





## 8.6.4 ProxFusion settings 3

# Capacitive sensing

		ProxF	usion setti	ngs 3_0/1/	2 (0x49 - 0	x4B)				
Bit Number	7	6	5	4	3	2	1	0		
Data Access	R/W	R/W	R/W	-	R/W	-	-	-		
Name	UP_LE	ENGTH	CS DIV	Internal use	UP LEN EN	-	-	-		
Default		0x06								
	0	0	0	0	0	1	1	0		

Bit definitions:

- Bit 7-6: Up length select (requires **UP\_LENGTH\_EN = 1** for use)
  - $\circ$  00: Up length = 0010
  - 01: Up length = 0110
- Bit 5: CS divider
  - $\circ$  0: Normal CS cap size
  - 1: CS cap size 5 times smaller
- Bit 3: Up length select enable
  - 0: Up length select is disabled
  - 1: Up length select is enabled (value in bit 7-6 is used)

#### Inductive sensing

	ProxFusion settings 3_0/1/2 (0x49 - 0x4B)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	-	-	R/W	-	R/W	-	-	-				
Name		-	CS DIV	Internal use	-	-	-	-				
Default	0x06											
Default	0	0	0	0	0	1	1	0				

Bit definitions:

• Bit 5: CS divider

 $\circ$  0: Normal CS cap size

 $\circ$  1: CS cap size 5 times smaller

• 10: Up length = 1010

0

11: Up length = 1110





## 8.7 ProxFusion sensor settings block 1

# 8.7.1 ProxFusion settings 4

## Capacitive sensing

			ProxFusio	n settings 4	(0x50)					
Bit Number	7	6	5	4	3	2	1	0		
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W		
Name	SAF	R UIs	TWO SIDED EN	ACF DISABLE	LTA	BETA	ACF	BETA		
Default				0x00						
Deidult	0	0	0	0	0	0	0	0		

Bit definitions:

- Bit 7-6: SAR UIs
  - o 00: Three channel discreet UI (multi-purpose sensing possibilities).
  - o 01: Two channel SAR proximity / touch / deep touch.
  - o 10: Single channel SAR (ch0) & Movement (ch1) UI enabled.
  - o 11: Same as '10' with hysteresis features on unused channel 2.
- Bit 5: Two-sided detection
  - 0: Bidirectional detection disabled
  - 1: Bidirectional detection enabled
- Bit 4: Disable AC filter
  - 0: AC filter enabled
- o 1: AC filter disabled

10:9

0

- Bit 3-2: Long term average beta value
   00: 7 01: 8
- Bit 1-0: AC filter beta value
  - ○
     00:1
     ○
     01:2
     ○
     10:3
     ○
     11:4

## Inductive sensing

	ProxFusion settings 4 (0x50)												
Bit Number	7	6	5	4	3	2	1	0					
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W					
Name	UI se	lection	TWO SIDED EN	ACF DISABLE	LTA I	BETA	ACF	BETA					
Fixed	0x20												
FIXed	0	0	1	0	0	0	0	1					

Bit definitions:

- Bit 7-6: UI selection
  - o 00: Two channel proximity / touch UI (multi-purpose)
  - o 01: Hysteresis options available on dedicated channel
  - o 10: Single channel SAR proximity / touch / movement UI is enabled
  - 11: Single channel SAR with hysteresis on dedicated channel.
- Bit 5: Two-sided detection
  - o 0: Bidirectional detection disabled

11:10

0



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	<ul> <li>1: Bidirectional detection</li> </ul>	tion	enabled				
٠	Bit 4: Disable AC filter						
	<ul> <li>0: AC filter enabled</li> </ul>			0	1: AC filter disabled		
•	Bit 3-2: Long term average b	oeta	value				
	o <b>00:</b> 7	0	01: 8	0	10: 9	0	11: 10
•	Bit 1-0: AC filter beta value						
	o <b>00: 1</b>	0	01: 2	0	10: 3	0	11: 4
. 7 0	DrovEucion cottingo E						

8.7.2 ProxFusion settings 5

#### IQS620A software number 0x08 = D'08 (Device version 1):

	ProxFusion settings 5 (0x51)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R/W	-	-	-	-	-	-	-			
Name	Disable Ch1 auto				Internal use						
Defeult		0x01									
Default	0	0	0	0	0	0	0	1			

Bit definitions:

- Bit7: Disable Ch1 auto
  - $\circ$  0: Ch1 is automatically enabled and disabled when SAR UI is active
  - o 1: Ch1 is manually enabled or disabled when SAR UI is active
- Bit 6-0: Internal use

## IQS620A software number 0x0D = D'13 (Device version 2 & 3):

	ProxFusion settings 5 (0x51)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	-	-	-	-	-	-	-				
Name	Disable Ch1 auto	Intern	al use	Disable fast debounce		Intern	al use					
Defeult		0x01										
Default	0	0	0	0	0	0	0	1				

- Bit7: Disable Ch1 auto
  - $\circ$  0: Ch1 is automatically enabled and disabled when SAR UI is active
  - $\circ$  1: Ch1 is manually enabled or disabled when SAR UI is active
- Bit 6-5: Internal use
- Bit 4: Disable fast debounce
  - 0: Fast debounce active in NP & LP modes
  - o 1: Fast debounce inactive in NP & LP modes
- Bit 3-0: Internal use





## 8.7.3 Compensation

	Compensation Ch0/1/2 (0x52 - 0x54)										
Bit Number	7	7 6 5 4 3 2 1 0									
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W			
Name		Compensation (7-0)									

Bit definitions:

- Bit 7-0: Compensation (7-0)
  - Lower 8-bits of the Compensation value.

#### 8.7.4 Multipliers

	Multipliers Ch0/1/2 (0x55-0x57)											
Bit Number												
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name	Compensation (9-8) Multiplier coarse Multiplier fine											

- Bit 7-6: Compensation (9-8)
  - Upper 2-bits of the Compensation value.
- Bit 5-4: Multiplier coarse
  - 0-3: Coarse multiplier selection
- Bit 3-0: Multiplier fine
  - 0-15: Fine multiplier selection





## 8.8 **ProxFusion UI settings**

# 8.8.1 Prox threshold Ch0/1/2

	Prox threshold Ch0/1/2 (0x60/0x62/0x64)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name				Prox thres	hold value							
Default	0x16 = D'22											
Deidult	0	0	0	1	0	1	1	0				

Bit definitions:

- Bit 7-0: Prox threshold = Prox threshold value
  - o 0-255: Prox threshold
  - o Ch0 Prox threshold ignored when SAR UI is active. Use SAR prox threshold 0x74

## 8.8.2 Touch threshold Ch0/1/2

	Touch threshold Ch0/1/2 (0x61/0x63/0x65)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W			
Name				Touch thres	nold value						
Default	0x25 = D'37										
Delault	0	0	1	0	0	1	0	1			

Bit definitions:

- Bit 7-0: Touch threshold = Touch threshold value \* LTA/ 256
  - 0-255\*LTA/256: Touch threshold

#### 8.8.3 ProxFusion discrete UI halt time

	ProxFusion discrete UI halt time (0x66)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name			Pro	xFusion disc	rete UI halt t	ime						
Dofault		0x28 = D'40 = 20sec										
Default	0	0	1	0	1	0	0	0				

- Bit 7-0: Halt time in 500ms increments (decimal value x 500ms)
  - o 0-127sec: ProxFusion discrete UI halt time
  - $\circ$  0xFF = 255: Never halt





## 8.9 Single channel SAR UI settings

# 8.9.1 Single channel SAR UI settings 0

	SAR UI settings 0 (0x70)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name	Fast mov beta		QRD Beta		SAR to GPIO0	S	low mov bet	а				
Default		0x16										
Deidult	0	0	0	1	0	1	1	0				

Bit definitions:

• Bit 7: Fast movement detection filter beta

• 1: beta = 3

- Bit 6-4: Quick Release Detection Beta
- 0-7: Quick Release Detection filter beta value
- Bit 3: SAR Standoff State to GPIO0
  - o 0: SAR standoff state to GPIO0 not active. RDY on GPIO0
  - 1: SAR standoff state to GPIO0 active. No RDY signal. For IQS620 use recommended schematic as shown in Figure 8.2 or contact Azoteq for more information.
- Bit 2-0: Slow movement detection filter beta
  - $\circ$  0-7: Slow movement filter beta value relative to fast beta

# For use with IQS620 (pre-production version 0):

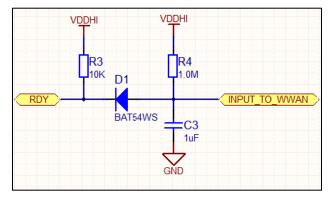


Figure 8.1 Recommended analog circuit when using GPIO0 output to drive a digital input (only required for IQS620). R4 and C3 Component values should be "select on test".

# For use with IQS620A (production version 1, 2 & 3):

There is no need for any additional analog circuitry for the IQS620A part except for the standard pull-up resistor as indicated in the schematic reference design. GPIO0/RDY pin is configured as an open drain active low logic I/O.





# 8.9.2 Single channel SAR UI settings 1

	SAR UI settings 1 (0x71)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name	L	TA halt time	out in no pro	х	Мс	ovement dete	ection thresh	old				
		0x25										
Default	1sec D'5											
	0	0	1	0	0	1	0	1				

Bit definitions:

- Bit 7-4: LTA halt timeout in no prox
  - 0-15: LTA halt timeout in no prox in 500ms increments (decimal value \* 500ms)
- Bit 3-0: Movement Detection Threshold
  - 0-15: Movement threshold = Movement threshold Value

8.9.3	Quick release	detection	threshold
-------	---------------	-----------	-----------

	Quick release detection threshold (0x72)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name				QRD Three	shold value							
Default	0x05											
Derduit	0	0	0	0	0	1	0	1				

- Bit 7-0: 0-255: QRD threshold = QRD threshold value
  - With ProxFusion settings 5 (0x51): bit 7 = 0: QRD threshold of 0 will prevent the system from entering movement detection timeout mode
  - With ProxFusion settings 5 (0x51): bit 7 = 1: QRD threshold of 0 will immediately on SAR proximity enter movement detection timeout mode.





## 8.9.4 Single channel SAR filter halt threshold

	SAR filter halt threshold (0x73)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name			SA	R filter halt t	hreshold val	ue						
Default	0x16 = D'22											
Deidult	0	0 0 0 1 0 1 1 0										

Bit definitions:

#### • Bit 7-0: SAR filter halt threshold = SAR filter halt threshold value

- o 0: Always halt
- 1-255: SAR filter halt threshold

#### 8.9.5 Single channel SAR prox threshold

	SAR prox threshold Ch0 (0x74)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name			:	SAR prox thr	eshold value	9						
Default	0x25 = D'37											
Derault	0	0	1	0	0	1	0	1				

Bit definitions:

• Bit 7-0: SAR prox threshold Ch0 = SAR prox threshold value

o 0-255: SAR prox threshold Ch0

## 8.9.6 Quick release detection halt time

	Quick release detection halt time (0x75)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name		LT	A halt timeo	ut after a QR	D (decimal \	alue x 500r/	is)					
Default	0x28 = D'40 = 20sec											
Deidult	0	0	1	0	1	0	0	0				

Bit definitions:

• Bit 7-0: LTA halt timeout after a Quick release detection with no movement afterwards (decimal value x 500ms)

# $\circ$ 0x00 - 0xFE = 0 - 127 seconds: QRD halt timeout

 $\circ$  0xFF = 255 = Never time-out





# 8.10 Hysteresis UI settings

# 8.10.1 Hysteresis UI settings

	Hysteresis UI settings (0x80)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	-	-	R/W	R/W	-	-	R/W	R/W				
Name	-	-	Hyster	resis T	-	-	Hyster	esis P				
Default	0xA2											
Derault	1	0	1	0	0	0	1	0				

Bit definitions:

•

- Bit 5-4: Touch hysteresis
  - o 00: Disabled
  - 01: 1/4 of threshold
  - Bit 1-0: Prox hysteresis
    - o 00: Disabled
    - 01: 1/4 of threshold

8.10.2 Hysteresis UI filter halt threshold

- o 10: 1/8 of threshold
- o 11: 1/16 of threshold
- o 10: 1/8 of threshold
- o 11: 1/16 of threshold

	Hysteresis UI filter halt threshold (0x81)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R/W	R/W R/W R/W R/W R/W R/W R/W									
Name			Hyster	esis UI filter l	nalt threshold	d value					
Default		0x0A = D'10									
Delault	0	0	0	0	1	0	1	0			

Bit definitions:

- Bit 7-0: Hysteresis UI filter halt threshold.
  - o 0: Always halt
  - o 1-254: Hysteresis UI filter halt threshold

## 8.10.3 Hysteresis UI prox threshold

		Hy	ysteresis U	II prox thre	shold (0x8	2)				
Bit Number	7	6	5	4	3	2	1	0		
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W		
Name			Hyste	resis UI pro	x threshold	value				
Default	0x16 = D'22									
Derduit	0	0	0	1	0	1	1	0		

Bit definitions:

• Bit 7-0: Hysteresis UI prox threshold

o 0-255: Hysteresis UI prox threshold





## 8.10.4 Hysteresis UI touch threshold

	Hysteresis UI touch threshold (0x83)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W R/W R/W R/W R/W R/W R/W										
Name			Hyste	eresis UI toud	h threshold	value						
Default		0x25 = D'37 * 4 = 148										
Delault	ault 0 0 1 0 0 1 0							1				

- Bit 7-0: Hysteresis UI touch threshold = Hysteresis UI touch threshold value \* 4
  - o 0-1020: Hysteresis UI touch threshold





# 8.11 Two channel SAR proximity / touch / deep touch UI settings

When implementing multiple threshold trigger thresholds, be sure.

# 8.11.1 2 Channel SAR UI settings

	Hysteresis UI settings (0x80)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	-	-	R/W	R/W R/W		-	R/W	R/W				
Name	-	-	Hyster	resis T	-	-	Hyster	esis P				
Fixed Value	-	-	0	0	-	-	0	0				

Bit definitions:

- Bit 5-4: Touch hysteresis
  - o 00: Disabled
- Bit 1-0: Prox hysteresis
  - o 00: Disabled

## 8.11.2 SAR Antenna 1 (pin Cx0) proximity threshold

	SAR Antenna 1 proximity threshold (0x60)											
Bit Number	7	7 6 5 4 3 2 1 0										
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name		SAR antenna 1 proximity threshold value										

Bit definitions:

- Bit 7-0: SAR antenna 1 proximity threshold
  - o 0-255: SAR antenna 1 proximity threshold

## 8.11.3 SAR Antenna 1 (pin Cx0) touch threshold

	SAR Antenna 1 touch threshold (0x61)											
Bit Number	7	7 6 5 4 3 2 1 0										
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name		SAR antenna 1 touch threshold value										

Bit definitions:

- Bit 7-0: Touch threshold = Touch threshold value \* LTA/ 256
  - o 0-255\*LTA/256: SAR antenna 1 touch threshold

## 8.11.4 SAR Antenna 1 (pin Cx0) deep touch threshold



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	SAR Antenna 1 deep touch threshold (0x63)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W			
Name	SAR antenna 1 deep touch threshold value										

Bit definitions:

Bit 7-0: Deep touch threshold = Deep touch threshold value \* LTA/ 256
 0-255\*LTA/256: SAR antenna 1 deep touch threshold

#### 8.11.5 SAR antenna 2 (pin Cx1) proximity threshold

	SAR antenna 2 proximity threshold (0x81)										
Bit Number											
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W			
Name		SAR antenna 2 proximity threshold value									

Bit definitions:

• Bit 7-0: SAR antenna 2 proximity threshold.

o 0-255: SAR antenna 2 proximity threshold

#### 8.11.6 SAR antenna 2 (pin Cx1) touch threshold

	SAR antenna 2 touch threshold (0x82)											
Bit Number												
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name	SAR antenna 2 touch threshold value											

Bit definitions:

• Bit 7-0 SAR antenna 2 touch threshold

o 0-255: SAR antenna 2 touch threshold

#### 8.11.7 SAR antenna 2 (pin Cx1) deep touch threshold

	SAR antenna 2 deep touch threshold (0x83)										
Bit Number											
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W			
Name	SAR antenna 2 deep touch threshold value										

Bit definitions:

Bit 7-0: SAR antenna 2 touch threshold = SAR antenna 2 deep touch threshold value \* 4
 0-1020: SAR antenna 2 deep touch threshold





## 8.12 Hall-effect sensor settings

## 8.12.1 Hall-effect settings 0

	Hall-effect settings 0 (0x90)												
Bit Number	7	6	5	4	3	2	1	0					
Data Access	-	-	R/W	R/W	-	-	R/W	R/W					
Name	-	-	CHARGI	E FREQ	rese	rved	AUTO A	TI MODE					
Default	0x03												
Default 0 0 0 0 0 0					0	1	1						

Bit definitions:

- Bit 5-4: Charge frequency divider
  - o 00: 1/2
  - o 01: 1/4

o **10: 1/8** 

o **11: 1/16** 

- Bit 1-0: Auto ATI Mode
  - o 00: ATI disabled
  - o 01: Partial ATI (all multipliers are fixed)
  - o 10: Semi-Partial ATI (only coarse multipliers are fixed)
  - o 11: Full-ATI

#### 8.12.2 Hall-effect settings 1

	Hall-effect settings 1 (0x91)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name	ATI_I	BASE			ATI_TAR	GET (x32)						
Default	0x50											
Deidult	0	1 0 1 0 0 0										

Bit definitions:

- Bit 7-6: Auto ATI base value
  - o **00:75**
  - o **01**: 100

o 10: 150

o **11: 200** 

- Bit 5-0: Auto ATI Target
  - $\circ$  ATI Target is 6-bit value x 32





## 8.12.3 Compensation Ch4 & 5

	Compensation Ch4 & 5 (0x92)											
Bit Number	7	7 6 5 4 3 2 1 0										
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name		Compensation (7-0)										

Bit definitions:

- Bit 7-0: Compensation (7-0)
  - 7-0: Lower 8-bits of the Compensation value.

## 8.12.4 Multipliers Ch4 & 5

	Multipliers Ch4 & 5 (0x93)											
Bit Number												
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name	Compensation (9-8) Multipliers coarse Multipliers fine											

- Bit 7-6: Compensation (9-8)
  - o 0-3: Upper 2-bits of the Compensation value.
- Bit 5-4: Multipliers coarse
  - o 0-3: Coarse multiplier selection
- Bit 3-0: Multipliers fine
  - 0-15: Fine multiplier selection





# 8.13 Hall-effect switch UI settings

# 8.13.1 Hall-effect switch UI settings

	Hall-effect switch UI settings (0xA0)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	-	R/W	R/W	R/W	-	R/W	R/W	R/W				
Name	-	Lin Mode	Hyster	esis T	-	Swap Dir	Hyster	esis P				
Default	0x00											
Deidult	0	0	0	0	0	0	0	0				

Bit definitions:

- Bit 6: Linearize Output
  - o 0: Disabled
- Bit 5-4: Touch Hysteresis
  - $\circ$  00: Disabled
  - o 01: 1/4 of threshold
- Bit 2: Swap field direction indication
  - o 0: Disabled
- Bit 1-0: Proximity Hysteresis
  - o 00: Disabled
  - o 01: 1/4 of threshold

## 8.13.2 Hall-effect switch UI prox threshold

- o 1: Enabled
- 10: 1/8 of threshold
- o 11: 1/16 of threshold
- o 1: Enabled
- o 10: 1/8 of threshold
- 11: 1/16 of threshold

	Hall-effect switch UI prox threshold (0xA1)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name				Prox thres	hold value							
Default	0x19 = D'25											
Deidult	0 0 0 1 1 0 0 1											

Bit definitions:

• Bit 7-0: Hall-effect switch UI prox threshold = Prox threshold value

o 0 – 255: Hall-effect switch UI prox threshold

## 8.13.3 Hall-effect switch UI touch threshold

	Hall-effect switch UI touch threshold (0xA2)										
Bit Number	7	7 6 5 4 3 2 1 0									
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W			
Name				Touch thre	shold value						
Default		0x19 =D'25									
Derault	0	0 0 0 0 0 0 0									

Bit definitions:

• Bit 7-0: Hall-effect switch UI touch threshold = Touch threshold value \* 4

 $\circ$  0 – 1020: Hall-effect switch UI touch Threshold





## 8.14 Temperature UI settings

Please note for IQS620A: The temperature calibration multiplier and divider values have been increased to 8-bit and thus uses individual full byte registers located at addresses 0xC2 & 0xC3. The Temperature calibration offset have resultantly moved to address 0xC4.

#### 8.14.1 Temperature UI settings

	Temperature UI settings (0xC0)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	-	R/W	R/W	R/W	R/W	R/W	R/W	R/W			
Name	-	Reseed in prox	Reseed enable		Rese	ed threshold	value				
Dofault	0x00										
Default	0	0	0	0	0	0	0	0			
Rit definitio	Bit definitions:										

Bit definitions:

- Bit 6: Reseed in prox • 0: Reseed cannot occur during a prox
- Bit 5: Reseed enable • o 0: Disabled
- Bit 4-0: Reseed threshold •  $\circ$  0 - 32: Reseed threshold = Reseed threshold value

8.14.2 Multipliers Ch3 Multipliers Ch3 (0xC1) Bit 7 6 5 3 2 4 1 0 Number Data R/W R/W R/W R/W R/W R/W \_ \_ Access Name \_ Multiplier coarse Multiplier fine -0x00 Default 0 0 0 0 0 0 0 0

- Bit 5-4: Multiplier coarse •
  - 0-3: Coarse multiplier selection
- Bit 3-0: Multiplier fine •
  - 0-15: Fine multiplier selection

- 1: Reseed can occur during a prox 0
- 1: Enabled 0





## For IQS620 only:

#### 8.14.3 Temperature calibration data0

	Temperature calibration data0 (0xC2)									
Bit Number	7	7 6 5 4 3 2 1 0								
Data Access		R/	W			R/	W			
Name	Τe	emperature r	nultiplier val	ue	Т	emperature	divider valu	e		
Default		0x00								
Deidult	0	0	0	0	0	0	0	0		

Bit definitions:

- Bit 7-4: Temperature multiplier value +1

   1 16: Temperature multiplier
- Bit 3-0: Temperature divider value + 1

   1 16: Temperature divider

Please note: Do not use the value 0xFF (0xF? or 0x?F) as this will result in overflow(s).

#### 8.14.4 Temperature calibration data1

Temperature calibration data1 (0xC3)									
Bit Number	7	7 6 5 4 3 2 1 0							
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W	
Name			-	Temperature	offset value	9			
Default	0x00								
Deidult	0	0	0	0	0	0	0	0	

Bit definitions:

• Bit 7-0: Temperature offset constant = Temperature offset value

o 0 – 255: Temperature offset constant





#### For IQS620A:

#### 8.14.5 Temperature calibration multiplier

	Temperature calibration multiplier (0xC2)										
Bit Number	7	7 6 5 4 3 2 1 0									
Data Access	R/W	R/W R/W R/W R/W R/W R/W R/W									
Name			Те	emperature r	nultiplier val	ue					
Default		0x00									
Delault	0	0 0 0 0 0 0 0									

Bit definitions:

Bit 7-0: Temperature calibration multiplier = Temperature multiplier value + 1

 1 – 256: Temperature calibration multiplier

Please note: Do not use the value 0xFF (D'255) as this will result in an overflow (255 + 1 = 256)

#### 8.14.6 Temperature calibration divider

	Temperature calibration divider (0xC3)									
Bit Number	7	7 6 5 4 3 2 1 0								
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W		
Name			Т	emperature	divider valu	e				
Default		0x00								
Delault	0	0	0	0	0	0	0	0		

Bit definitions:

• Bit 7-0: Temperature calibration divider = Temperature divider value + 1

 $\circ$  1 – 256: Temperature calibration divider

#### Please note: Do not use the value 0xFF (D'255) as this will result in an overflow (255 + 1 = 256)

#### 8.14.7 Temperature calibration offset

	Temperature calibration offset (0xC4)									
Bit Number	7	7 6 5 4 3 2 1 0								
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W		
Name			_	Temperature	e offset value	9				
Default		0x00								
Delault	0	0	0	0	0	0	0	0		

Bit definitions:

• Bit 7-0: Temperature offset constant = Temperature offset value

o 0 – 255: Temperature offset constant





# 8.15 Device and power mode settings

## 8.15.1 System settings

	System settings (0xD0)										
Bit Number	7	6	5	4	3	2	1	0			
Data Access	W=1	W=1	R/W	R/W	R/W	R/W	W=1	W=1			
Name	SOFT RESET	ACK RESET	EVENT MODE	4MHz	COMMS ATI	ATI BAND	REDO ATI	RESEED			
Default	0x08										
Deidult	0	0	0	0	1	0	0	0			

Bit definitions:

- Bit 7: Software Reset (Set only, will clear when done)
  - 1: Causes the device to perform a WDT reset
- Bit 6: ACK Reset (Set only, will clear when done)
  - 1: Acknowledge that a reset has occurred. This event will trigger until acknowledged.
- Bit 5: Event mode enable
  - o 0: Event mode disabled. Default streaming mode communication.
  - 1: Event mode communication enabled.
- Bit 4: Main clock frequency selection
  - o 0: Run FOSC at 16MHz

• 1: Run FOSC at 4MHz

- Note: Do not configure main clock frequency selection and command a re-ATI in the same communication window. First configure the main oscillator and issue an I<sup>2</sup>C stop to let the selection first take effect. Then command a re-ATI in a following/subsequent communication window to prevent ATI execution errors.
- Bit 3: Communications during ATI
  - o 0: No communications are generated during ATI
  - 1: Communication continue as setup regardless of ATI state.
- Bit 2: Re-ATI Band selection
  - 0: Re-ATI when outside 1/8 of ATI target
  - 1: Re-ATI when outside 1/16 of ATI target
- Bit 1: Redo ATI on all channels (*Set only, will clear when done*)
  - 1: Redo the ATI on all channels
    - Note: See usage warning above with bit 4: Main clock frequency selection.
- Bit 0: Reseed all Long-Term-Average (LTA) filters (Set only, will clear when done)
  - 1: Reseed all channels (irrespective of the <u>channel reseed enable byte (0xDB)</u> for IQS620A)





## 8.15.2 Active channels

	Active channels (0xD1)										
Bit Number	7	7 6 5 4 3 2 1 0									
Data Access	-	R/W R/W R/W R/W R/W									
Name	-	-	Ch5	Ch4	Ch3	Ch2	Ch1	Ch0			
Default	0x3F										
Deidult	0 0 1 1 1 1 1 1										

Bit definitions:

•	Bit 5: Ch	5 ( <b>note: Ch4 &amp; 5 must both be en</b> a	abled for Hall-effect UI to be functional)	
	o 0	Channel is disabled	<ul> <li>1: Channel is enabled</li> </ul>	

- Bit 4: Ch4 (*note: Ch4 & 5 must both be enabled for Hall-effect UI to be functional*)

   0: Channel is disabled
   0 1: Channel is enabled
- Bit 3: Ch3 (*note: Ch3 must be enabled for temperature UI to be functional* 
   0: Channel is disabled
   1: Channel is enabled
- Bit 2: Ch2 (*note: Ch2 must be enabled for Hysteresis UI to be functional*)
   0: Channel is disabled
   1: Channel is enabled
- Bit 1: Ch1 (note: Ch0 and Ch1 must both be enabled for SAR UI to be functional)
  - 0: Channel is disabled
- 1: Channel is enabled
- Bit 0: Ch0 (note: Ch0 and Ch1 must both be enabled for SAR UI to be functional)
  - 0: Channel is disabled

o 1: Channel is enabled





#### 8.15.3 Power mode settings

	Power mode settings (0xD2)											
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W R/W R/W						
Name	PWM OUT	EN ULP MODE	DSBL AUTO MODE	POWER	MODE	NP SEG RATE						
Default	0x03											
Deidult	0	0	0	0	0 0 0 1							

- Bit 7: PWM output activation
  - 0: PWM output inactive on GPIO3 (LTX available for use)
  - 1: PWM output active on GPIO3 (LTX disabled; no inductive sensing possible)
    - Please note: IQS620A will stay in normal power mode when the PWM output is active.
- Bit 6: Allow auto ultra-low power mode switching
  - o 0: ULP is disabled during auto-mode switching
  - 1: ULP is enabled during auto-mode switching
- Bit 5: Disable auto mode switching
  - 0: Auto mode switching is enabled
  - 1: Auto mode switching is disabled
- Bit 4-3: Manually select power mode (*note: bit 5 must be set for static power modes*)
  - 00: Normal Power mode. The device runs at the normal power rate, all enabled channels and UIs will execute.
  - 01: Low Power mode. The device runs at the low power rate, all enabled channels and UIs will execute.
  - 10: Ultra-Low Power mode. The device runs at the ultra-low power rate, Ch0 is run as wake-up channel. The other channels execute at the NP-segment rate.
  - 11: Halt Mode. No conversions are performed; the device must be removed from this mode using an I<sup>2</sup>C command.
- Bit 2-0: Normal power update rate
  - 000: ½ ULP rate
  - o 001: 1/4 ULP rate
  - o 010: 1/8 ULP rate
  - 011: <sup>1</sup>/<sub>16</sub> ULP rate

- $\circ$  100:  $^{1}\!/_{32}$  ULP rate
- 101: <sup>1</sup>/<sub>64</sub> ULP rate
- 110: <sup>1</sup>/<sub>128</sub> ULP rate
- 111: <sup>1</sup>/<sub>256</sub> ULP rate





#### 8.15.4 Normal power mode report rate

	Normal power mode report rate (0xD3)											
Bit Number	7	7 6 5 4 3 2 1 0										
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name			Norma	l power mod	le report rate	e in ms						
Default		0x10 = D'16 = 16ms										
Derault	t 0 0 0 1 0 0 0											

Bit definitions:

- Bit 7-0: Normal power mode report rate in ms (*note: LPOSC timer has +- 4ms accuracy*)
  - o 0-255ms: Normal mode report rate

Please note: Report rates faster than 4ms may not be reached due to conversion time required according to channel setup and communication speed.

#### 8.15.5 Low power mode report rate

Low power mode report rate (0xD4)											
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W			
Name	Low power mode report rate in ms										
Default	0x30 = D'48 = 48ms										
	0	0	1	1	0	0	0	0			

Bit definitions:

Bit 7-0: Low power mode report rate in ms (*note: LPOSC timer has +- 4ms accuracy*)

 0-255ms: Low-power mode report rate

Please note: Report rates faster than 4ms may not be reached due to conversion time required according to channel setup and communication speed.

#### 8.15.6 Ultra-low power mode report rate

Ultra-low power mode report rate (0xD5)											
Bit Number	7	6	5	4	3	2	1	0			
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W			
Name	Ultra-low power mode report rate value * 16ms										
Default	0x08 = D'08 * 16 = 128ms										
	0	0	0	0	1	0	0	0			

- Bit 7-0: Ultra-low power mode report rate = Ultra-low power mode report rate value \*16ms
  - 0-4080ms: Ultra-low power mode report rate



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# 8.15.7 Auto mode timer

	Auto mode timer (0xD6)												
Bit Number	7	6	5	4	3	2	1	0					
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W					
Name			Auto	o mode time	r value * 500	)ms							
Default			0	x14 = D'20 *	500 = 10se	С							
Delault	0	0	0	1	0	1	0	0					

Bit definitions:

• Bit 7-0: Auto modes switching time = Auto mode timer value \* 500ms

o 0-127.5s: Auto mode switching time





# 8.15.8 Global event mask

			Globa	event ma	sk (0xD7)								
Bit Number	7	6	5	4	3	2	1	0					
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W					
Name	SAR ACTIVE	PMU EVENT	SYS EVENT	TEMP EVENT	HYSTE- RESIS UI EVENT	HALL EVENT	SAR EVENT	PROX SENSE EVENT					
Default		0x00											
Deidult	0	0	0	0	0	0	0	0					

Bit definitions:

- Bit 7: SAR activation state mask
  - 0: Event is allowed
- Bit 6: Power management unit event mask
  - o 0: Event is allowed
- Bit 5: System event mask
  - 0: Event is allowed
- Bit 4: Temperature event mask
  - o 0: Event is allowed
- Bit 3: Hysteresis UI event mask
  - o 0: Event is allowed
- Bit 2: Hall-effect event mask
  - o 0: Event is allowed
- Bit 1: SAR event mask
  - o 0: Event is allowed
- Bit 0: ProxSense event mask
  - 0: Event is allowed

# 8.15.9 PWM duty cycle

8.15.9 PV	vivi auty cy	cie										
PWM duty cycle (0xD8)												
Bit Number	7	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name				PWM duty	cycle value							
Default				0x	00							
Derault	0	0	0	0	0	0	0	0				

Bit definitions:

- Bit 7-0: PWM duty cycle (%) = (PWM duty cycle value + 1) / 256 \* 100
  - o 0.4 100%: PWM duty cycle of the fixed 1kHz PWM output available on GPIO3
  - Requires the activation of PWM OUT bit in Power mode settings 0xD2: bit7

- 1: Event is masked
- o 1: Event is masked





# For the IQS620A only:

#### **RDY timeout period** 8.15.10

			RDY tim	eout perio	d (0xD9)							
Bit Number	S	6	5	4	3	2	1	0				
Data Access	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W				
Name			F	RDY timeout	period value	e						
Default		0x20 = D'32 * 0.32ms = 10.24ms										
Delault	0	0	1	0	0	0	0	0				

Bit definitions:

#### Bit 7-0: RDY timeout period = RDY timeout period value \* 0.32ms •

○ 0 – 81.6ms: RDY timeout period

#### 8.15.11 I<sup>2</sup>C settings

	I <sup>2</sup> C settings (0xDA)												
Bit Number	7	6	5	4	3	2	1	0					
Data Access	R/W	-	-	-	-	-	-	R/W					
Name	STOP DISABLE			Rese	erved			1					
Default	0x01												
Delault	0	0	0	0	0	0	0	1					

Bit definitions:

Bit 7: Stop disable •

- 0: Stop enabled: Stop bit will exit the communication window.
- 1: Stop disabled: Stop bit will not exit the communication window. No start within the 0 RDY timeout period (0xD9) will exit the communication window.
- Bit 6 1: Reserved •

- Bit 0: Reserved •
- Do not configure, leave cleared.
- Must always be set (bit 0 = 1).

8.15.12

- **Channel reseed enable**

			Channel r	eseed ena	ble (0xDB)			
Bit Number	7	6	5	4	3	2	1	0
Data Access	-	-	-	-	-	R/W	R/W	R/W
Name	-	-	-	-	-	Ch2	Ch1	Ch0
Default				0x	07			
Delault	0	0	0	0	0	1	1	1
Dit definiti								

Bit definitions:

• Bit 2-0: Channel reseed enable bit

o 0: Channel reseed disabled

- 1: Channel reseed enabled
- o Please note: This byte enables/disables only auto reseed commands upon either:
  - ProxFusion discrete UI halt timeout (0x66) \_
  - Quick release detection halt timeout (0x75) \_





# 9 Electrical characteristics

# 9.1 Absolute Maximum Specifications

The following absolute maximum parameters are specified for the device: *Exceeding these maximum specifications may cause damage to the device.* 

# Table 9.1Absolute maximum specification

Parameter	Absolute maximum			
Operating temperature	-20°C to 85°C			
Supply Voltage (VDDHI – GND)	+3.6V			
Maximum pin voltage	VDDHI + 0.5V (may not exceed VDDHI max)			
Maximum continuous current (for specific pins)	10mA			
Minimum pin voltage	GND - 0.5V			
Minimum power-on slope	100V/s			
ESD protection	±8kV (Human body model)			

# 9.2 Voltage regulation specifications

# Table 9.2Internal voltage regulator operating conditions

DESCRIPTION	CHIPSET	PARAMETER	MIN	TYPICAL	MAX	UNIT
Supply voltage	IQS620A	VDDHI	1.764	- 3.6		V
Internal voltage regulator	IQSUZUA	VREG	1.61	1.66	1.71	v

9.3 Reset conditions

# Table 9.3Device reset specifications

DESCRIPTION	Conditions	PARAMETER	MIN	MAX	UNIT
Power On Reset	VDDHI Slope ≥ 100V/s¹	PORvddhi	0.302	1.70	V
VDDHI Brown Out Detect	VDDHI Slope ≥ 100V/s¹	BODvddhi	N/A	1.60	V
VREG Brown Out Detect	VDDHI Slope ≥ 100V/s¹	BOD <sub>VREG</sub>	N/A	1.583	V

<sup>&</sup>lt;sup>1</sup>Applicable to full "operating temperature" range

 $<sup>^2</sup>For$  a power cycle, ensure lowering  $V_{\text{DDHI}}$  below the minimum  $\text{POR}_{\text{VDDHI}}$  value before ramping  $V_{\text{DDHI}}$  past the maximum  $\text{POR}_{\text{VDDHI}}$  value

<sup>&</sup>lt;sup>3</sup>In Figure 1.4 & Figure 1.5 capacitors C2 & C3 should be chosen to comply with this specification



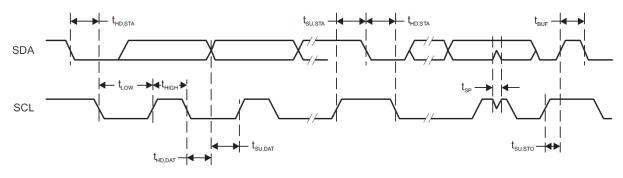


# 9.4 I<sup>2</sup>C module specifications

Specified over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted).

# Table 9.4I<sup>2</sup>C module specifications

	PARAMETER	TEST CONDITIONS	V <sub>ddhi</sub>	MIN	ТҮР	MAX	UNIT
<b>f</b> <sub>SYS</sub>	System clock frequency				16		MHz
f <sub>SCL</sub>	SCL clock frequency		1.8V - 3V	0		400	kHz
<b>t</b> hd,sta	Hold time (repeated) START	f <sub>SCL</sub> = 100 kHz	1.8V - 3V	4.0			μs
		f <sub>SCL</sub> > 100 kHz		0.6			
tsu,sta	Setup time for a repeated	f <sub>SCL</sub> = 100 kHz	1.8V - 3V	4.7			μs
	START	f <sub>SCL</sub> > 100 kHz		0.6			
t <sub>hd,dat</sub>	Data hold time		1.8V - 3V	0			ns
<b>t</b> su,dat	Data setup time		1.8V - 3V	250			ns
<b>t</b> su,sто	Setup time for STOP	f <sub>SCL</sub> = 100 kHz	1.8V - 3V	4.0			μs
		f <sub>SCL</sub> > 100 kHz		0.6			
t <sub>SP</sub>	Pulse duration of spikes suppressed by input filter	N/A	1.8V - 3V	No pulse suppression filter		ns	
t <sub>LOW</sub>	Clock low time-out	N/A	1.8V - 3V	TBD			ms









# 9.5 I<sup>2</sup>C module output logic fall time limits

# Table 9.5I<sup>2</sup>C module output logic fall time specifications

DESCRIPTION	VDDHI (V)	Temp (°C)	Pull-up resistor (Ω)	C <sub>LOAD</sub> (pF)	SYMBOL	MIN	MAX	UNIT
		20	7000	50		11.80		
		-20	885	400		28.70		
	1.8	. 05	7000	50		11.80		
	1.0	+25	885	400		30.70		
		+85	7000	50		11.80		
SDA & SCL minimum fall		CO+	885	400	Τ	33.80		
times		20	7000	50	TF_min	7.90		
umes		-20	885	400		18.60		
	3.3	+25	7000	50		7.80		
	5.5		885	400		19.70		
		+85	7000	50		7.90		ns
			885	400		21.50		
		-20	420	50			42.50	
			420	400			65.10	
	1.8	+25	420	50			43.40	
	1.0	+23	420	400			69.70	
		+85	420	50			45.30	
SDA & SCL maximum fall		+00	420	400	Τ-		77.30	
times		-20	770	50	T <sub>F_max</sub>		20.20	
		-20	770	400			32.80	
	3.3	+25	770	50			19.90	
	5.5	720	885	400			34.30	
		+85	770	50			20.00	
		700	770	400			36.80	





# 9.6 I<sup>2</sup>C module slew rates

# Table 9.6 I<sup>2</sup>C module fastest falling slew rates and matching rising slew rates

DESCRIPTION	VDDHI (V)	Conditions	Fall time (ns)	Rise time (ns)	SYMBOL	SR	UNIT
SDA & SCL slew	1.8	$C_{BUS} = 50 pF$	11.80		SRFALL	61.02	
rates for the	1.0	R <sub>PU</sub> = 7kΩ T <sub>A</sub> = -20°C		296.55	SRRISE	2.43	
minimum allowed bus	3.3	C <sub>BUS</sub> = 50pF R <sub>PU</sub> = 7kΩ	7.90		SRFALL	167.09	
capacitance		$T_{A} = -20^{\circ}C$		296.55	SRRISE	4.45	V/µs
SDA & SCL slew	4.0	C <sub>BUS</sub> = 400pF	28.70		SRFALL	25.09	'/μs
rates for the	1.8	R <sub>PU</sub> = 885Ω T <sub>A</sub> = -20°C		299.94	SR <sub>RISE</sub>	2.40	
maximum allowed bus		$C_{BUS} = 400 pF$	18.60		SRFALL	70.97	
capacitance	3.3	R <sub>PU</sub> = 885Ω T <sub>A</sub> = -20°C		299.94	SRRISE	4.40	

 Table 9.7
 I<sup>2</sup>C module slowest falling slew rates and matching rising slew rates

DESCRIPTION	VDDHI (V)	Conditions	Fall time (ns)	Rise time (ns)	SYMBOL	SR	UNIT	
SDA & SCL slew	1.8	C <sub>BUS</sub> = 50pF R <sub>PU</sub> = 420Ω	45.30		SR <sub>FALL</sub>	15.89		
rates for the	1.0	$T_A = +85^{\circ}C$		17.79	SRRISE	40.47		
minimum allowed bus	2.2	С <sub>виз</sub> = 50рF	20.20		SRFALL	65.35		
capacitance	3.3	R <sub>PU</sub> = 770Ω T <sub>A</sub> = -20°C		32.62	SR <sub>RISE</sub>	40.47	V/	
SDA & SCL slew			$C_{BUS} = 400 pF$	77.30		SRFALL	9.31	V/µs
rates for the	1.8	R <sub>PU</sub> = 420Ω T <sub>A</sub> = +85°C		142.34	SRRISE	5.06		
maximum allowed bus capacitance 3.	2.2	C <sub>BUS</sub> = 400pF	36.80		SRFALL	35.87		
	3.3 R <sub>PU</sub> = 770Ω T <sub>A</sub> = +85°C		260.96	SR <sub>RISE</sub>	5.06			





# 9.7 I<sup>2</sup>C pins (SCL & SDA) input/output logic levels

 Table 9.8
 I<sup>2</sup>C pins (SCL & SDA) input and output logic level boundaries

DESCRIPTION	Conditions	SYMBOL	Temperature	MIN	TYP	MAX	UNIT		
			-20°C	32.12					
Input low level voltage		Vin_LOW	+25°C		34.84				
voltage			+85°C			39.39			
lument bink laval	100kU= 120	40064-120	400kHz l <sup>2</sup> C		-20°C			71.51	
Input high level voltage	400kHZ I-C	Vin_HIGH	+25°C		68.18		% of		
voltage	frequency		+85°C	66.06			VDDHI		
Output low level voltage		$V_{\text{out}\_\text{LOW}}$	-20°C – +85°C		0				
Output high level voltage		$V_{out\_HIGH}$	-20°C – +85°C		100				

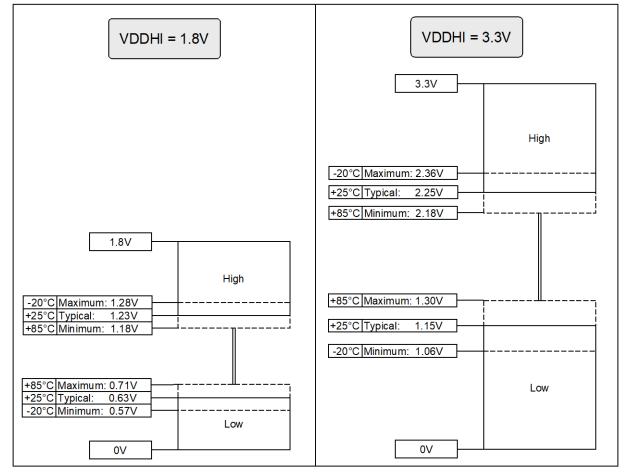


Figure 9.2 Calculated input buffer trigger levels for I<sup>2</sup>C pins at 400kHz clock frequency for 1.8V and 3.3V VDDHI power supplies

# 9.8 General purpose digital output pins (GPIO0 & GPIO3) logic levels

DESCRIPTION	SYMBOL	Temperature	MIN	TYP	MAX	UNIT
Output low level voltage	Vout_LOW	-20°C – +85°C		0		% of
Output high level voltage	Vout_HIGH	-20°C - +85°C		100		VDDHI





# 9.9 Current consumptions

# 9.9.1 IC subsystems

# Table 9.9IC subsystem current consumption

Description	PARAMETER	TYPICAL	MAX	UNIT
Core active	<b>I</b> ACTIVE	339	377	μA
Core sleep	ISLEEP	0.63	1	μA

# Table 9.10 IC subsystem typical timing

Power mode	Core active	Core sleep	Total	Unit
NP mode	5	5	10	ms
LP mode	5	43	48	ms
ULP mode	1.75	128	129.75	ms

# 9.9.2 Capacitive sensing alone

# Table 9.11 Capacitive sensing current consumption

Power mode	Supply voltage	Report rate	TYPICAL	UNIT
	VDD = 1.8V	10ms	90.18	
NP mode	VDD = 3.3V	10ms	91.00	
	VDD = 1.8V	48ms	32.97	A
LP mode	VDD = 3.3V	48ms	32.80	μA
ULP mode	VDD = 1.8V	128ms	11.69	
OLF Mode	VDD = 3.3V	128ms	11.35	

-These measurements where done on the default setup of the IC

#### Table 9.12 Single capacitive wake-up channel current consumption

Power mode	Supply voltage	Charging frequency	ATI target	Report rate	TYPICAL	UNIT
ULP mode	VDD = 1.8V	2MHz	192	256ms	2.23	٨
	VDD = 3.3V	2MHz	192	256ms	2.57	μA

-These measurements where done with enhanced settings for minimum current consumption for a single touch channel

# 9.9.3 Capacitive sensing with SAR UI active

# Table 9.13 Capacitive sensing and SAR UI current consumption

Power mode	Supply voltage	Report rate	TYPICAL	UNIT
ND we add	VDD = 1.8V	10ms	75.34	
NP mode	VDD = 3.3V	10ms	75.43	
LP mode	VDD = 1.8V	48ms	27.76	
LP mode	VDD = 3.3V	48ms	27.37	μΑ
LIL Duranda	VDD = 1.8V	128ms	11.72	
ULP mode	VDD = 3.3V	128ms	11.25	

-These measurements where done on the default setup of the IC





# 9.9.4 Temperature monitoring alone

# Table 9.14 Temperature monitoring current consumption

Power mode	Supply voltage	Report rate	TYPICAL	UNIT
NP mode	VDD = 1.8V	10ms	68.87	
NF IIIOde	VDD = 3.3V	10ms	69.08	
LP mode	VDD = 1.8V	48ms	24.60	
	VDD = 3.3V	48ms	24.10	μΑ
	VDD = 1.8V	128ms	22.67	
ULP mode	VDD = 3.3V	128ms	22.12	

-These measurements where done on the default setup of the IC

#### 9.9.5 Hall-effect sensing alone

# Table 9.15 Hall-effect current consumption

Power mode	Supply voltage	Report rate	TYPICAL	UNIT
NP mode	VDD = 1.8V	10ms	104.82	
NF Mode	VDD = 3.3V	10ms	104.42	
LP mode	VDD = 1.8V	48ms	38.11	
	VDD = 3.3V	48ms	37.44	μA
ULP mode	VDD = 1.8V	128ms	N/A <sup>(1)</sup>	
	VDD = 3.3V	128ms	N/A <sup>(1)</sup>	

-These measurements where done on the default setup of the IC

(1) -It is not advised to use the IQS620A in ULP without capacitive sensing. This is due to the Hall-effect sensor being disabled in ULP.

#### 9.9.6 Inductive sensing alone

#### Table 9.16 Inductive sensing current consumption

Power mode	Supply voltage	Report rate	TYPICAL	UNIT
NP mode	VDD = 2.0V	10ms	116.50 (1)	
	VDD = 3.3V	10ms	130.10 (1)	
LP mode	VDD = 2.0V	48ms	41.34 (1)	
	VDD = 3.3V	48ms	46.31 (1)	μA
ULP mode	VDD = 2.0V	128ms	N/A (2)	
OLF Mode	VDD = 3.3V	128ms	N/A (2)	

-These measurements where done on the default setup of the IC

(1) -Measurements where conducted with a recommended inductive coil layout.

(2) -It is not advised to use the IQS620A in ULP without capacitive sensing. This is due to the Inductive sensor UI channel being disabled in ULP.

#### 9.9.7 Halt mode

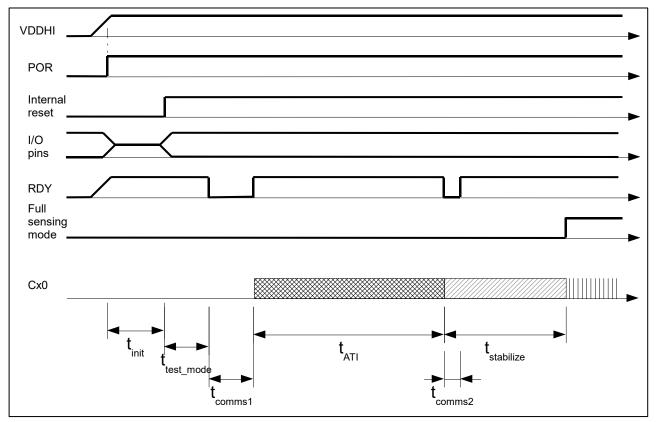
#### Table 9.17Halt mode current consumption

Power mode	Conditions	Report rate	TYPICAL	UNIT
Halt mode	VDD = 1.8V	Nono	1.6	
Halt mode	VDD = 3.3V	None	1.9	μA





# 9.10 Start-up timing specifications



# Figure 9.3 IQS620A start-up timing diagram

# Table 9.18Timing values for IQS620A start-up timing diagram

Timing	Min	Typical	Мах
tinit		6ms	
t <sub>test_mode</sub>		5ms	
t <sub>comms1</sub> (16 MHz)	until I2C stop bit		10ms (time-out)
t <sub>comms1</sub> (4 MHz)	until I2C stop bit		40ms (time-out)
t <sub>ATI</sub> (1 6MHz)		110ms (default settings)	
t <sub>ATI</sub> (4 MHz)		420ms (default settings)	
t <sub>comms2</sub> (event mode enabled – system event)	until I2C stop bit		Time-out value defined in register 0xD9 (x4 for 4 MHz mode)
t <sub>stabilize</sub> (16 MHz)	40ms	70ms (default settings)	
t <sub>stabilize</sub> (4 MHz)	120ms	140ms (default settings)	
t <sub>full_sensing_mode</sub> (16 MHz)		201ms (from POR)	
t <sub>full_sensing_mode</sub> (4 MHz)		611ms (from POR)	





# **10** Package information

# 10.1 DFN(3x3)-10 package and footprint specifications

# Table 10.1DFN(3x3)-10 Package<br/>dimensions (bottom)

Dimension	[mm]
А	3 ±0.1
В	0.5
С	0.25
D	n/a
F	3 ±0.1
L	0.4
Р	2.4
Q	1.65

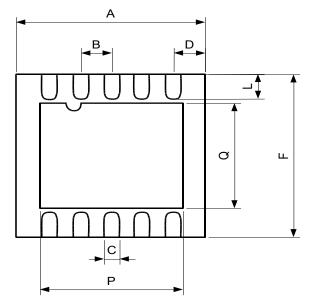


Figure 10.1 *DFN(3x3)-10 Package dimensions (bottom view). Note that the saddle needs to be connected to common GND on the PCB.* 

# Table 10.2DFN(3x3)-10 Package<br/>dimensions (side)

Dimension	[mm]
G	0.05
Н	0.65
	0.7-0.8

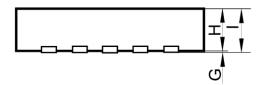


Figure 10.2 DFN(3x3)-10 Package dimensions (side view)

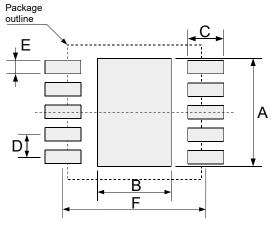


Figure 10.3 DFN(3x3)-10 Landing pad dimensions (top view)

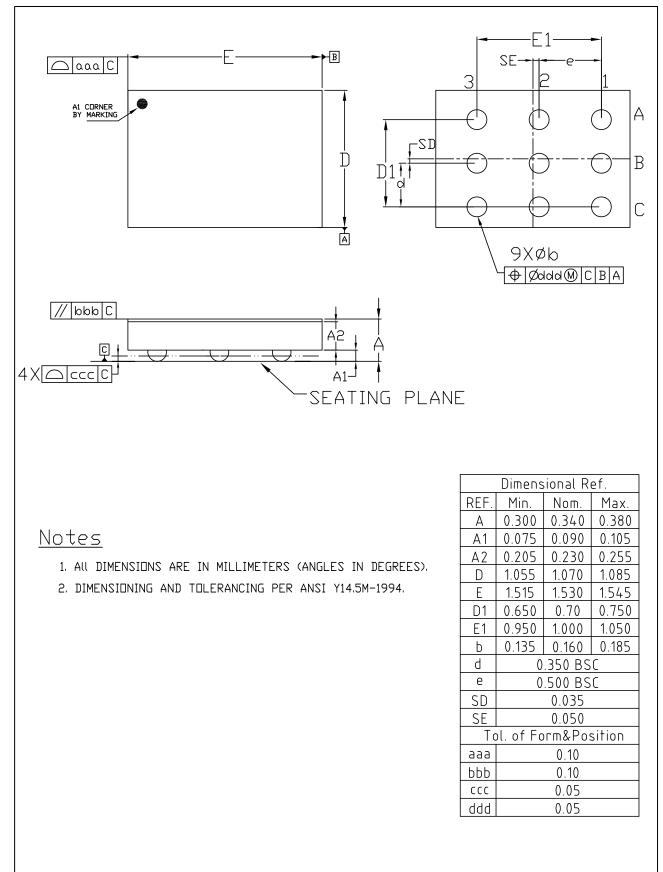
# Table 10.3DFN(3x3)-10 Landing pad<br/>dimensions

Dimension	[mm]
A	2.4
В	1.65
С	0.8
D	0.5
E	0.3
F	3.2





# 10.2 WLCSP-9 package and footprint specification



# Figure 10.4 IQS620A WLCSP-9 package dimensions





# 10.3 Device marking and ordering information

# 10.3.1 Device marking:

The devices can be identified from the top-side marking on the device package as shown below:

	DFN(3x3)-10		
	IQS620A = Device name		
& Azoteq	X = Additional option ('Blank' = Default, T = temperature calibrated)		
IQS620A vi z PWWYY	v = Product version mark (0 – Pre-production, 1 – Production, 2 – FW update,		
	3 – HW update)		
Or i = Industrial temperature range			
Azoteq IQS620AX v i z PWWYY	z = Configuration ( $I^2C$ address: 0 = 44H, 1 = 45H) <sup>1</sup>		
	P = Packaging house (1,2)		
	WWYY = Date code (week, year)		
	• = Pin A1 indicator		
	WLCSP-9		
	620A = device name (IQS620A)		
	X = Additional option (T = temperature calibrated)		
	z = Configuration (I <sup>2</sup> C address: 0 = 44H, 1 = 45H) <sup>1</sup>		
620A	v = Product version mark (0 – Pre-production, 1 – Production, 2 – FW update,		
Xzvp ppxx	3 – HW update)		
•	ppp = Product code		
	xx = batch code (AA, AB ZZ)		
	• = Pin A1 indicator		

<sup>&</sup>lt;sup>1</sup> Other sub-address configurations are available on special request, see section 7.5.





# **11 Ordering information:**

<u>IQS620A</u>	X	Z	<u>pp</u>	b	
Device name	Additional option	Configuration (I <sup>2</sup> C address)	Package type	Bulk packaging	
IQS620A T		0			IQS620A0DNR
		1	DN	5	IQS620A1DNR
	т	0	0 1		IQS620AT0DNR
	I	1			R
		0	00		IQS620A0CSR
		1	CS		IQS620A1CSR

# $\underline{\mathbf{X}}$ – Additional option

- 'Blank': Default device option
  - T: Temperature calibrated (only used in order code for temperature calibrated DN parts;
    - Any CS parts are temperature calibrated by default)

#### $\underline{z}$ – Configuration (I<sup>2</sup>C address)

- 0: 44H default address
- 1: 45H sub-address

# **pp** – Package type

- DN: DFN(3x3)-10
- CS: WLCSP-9
- <u>**b**</u> Bulk packaging

•

R: Reel (3k/reel, MOQ=1 reel)

#### Example: IQS620AT0DNR

- **T** Temperature calibrated
- 0 configuration is default (44H default I<sup>2</sup>C address)
- DN DFN(3x3)-10 package
- R packaged in reels of 3k (must be ordered in multiples of 3k)

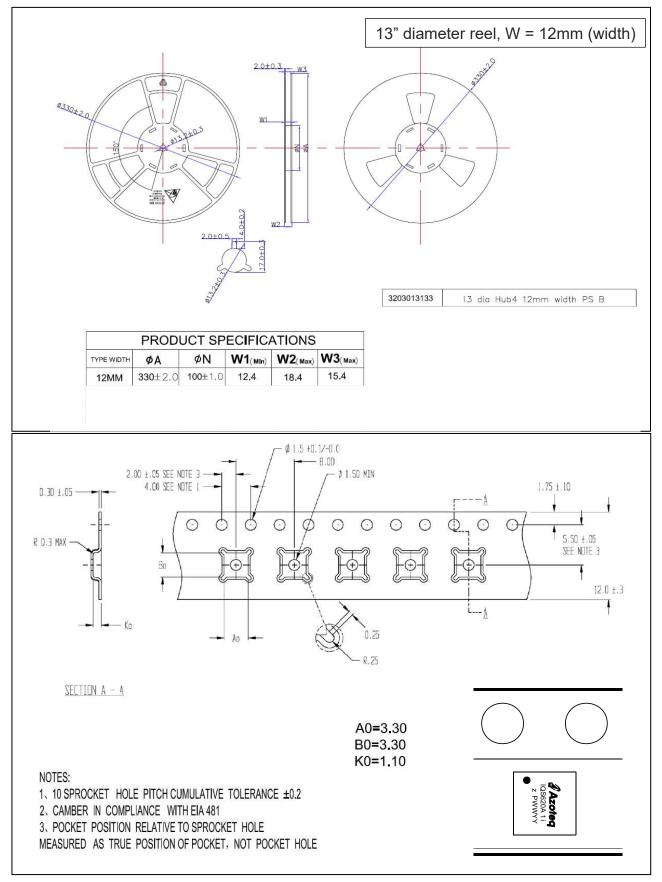


IQ Switch® ProxFusion® Series



# 11.1 Tape and reel specification

# 11.1.1 DFN(3x3)-10



# Figure 11.1 IQS620A DFN(3x3)-10 tape & reel specification



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# 11.1.2 WLCSP-9

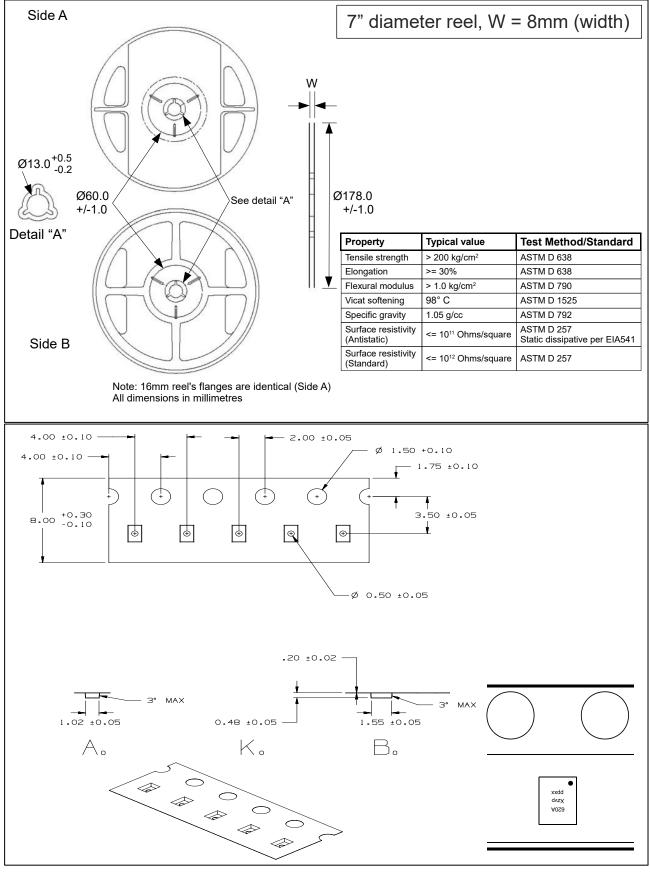


Figure 11.2 IQS620A WLCSP-9 tape & reel specification





# 11.2 MSL Level

**Moisture Sensitivity Level** (MSL) relates to the packaging and handling precautions for some semiconductors. The MSL is an electronic standard for the time period in which a moisture sensitive device can be exposed to ambient room conditions (approximately 30°C / 85%RH see J-STD033C for more info) before reflow occur.

# Table 11.1 Package moisture sensitivity level ratings

Package	Level (duration)
	MSL 1 (Unlimited at ≤30°C / 85% RH)
DFN(3x3)-10	Reflow profile peak temperature < 260°C for < 25 seconds
	Number of reflows < 3
	MSL 1 (Unlimited at ≤30°C / 85% RH)
WLSCP-9	Reflow profile peak temperature < 260°C for < 25 seconds
	Number of reflows < 3



IQ Switch® **ProxFusion® Series** 



# 12 Datasheet revisions

# 12.1 Revision history

- v1.00: First release version
- v1.10: Datasheet update:
  - I<sup>2</sup>C transaction detail added.
    - Document navigational bookmarks added.
- v1.11: Datasheet update:
  - IQS620A: 1.8V 3.3V supply voltage range product addition.
  - Device marking and ordering info updated.
- v1.12: Datasheet update:
  - Metal detect UI changed to Hysteresis UI.
  - Hysteresis UI described for both capacitive and inductive sensing options.
  - Temperature sensing changed to Temperature monitoring. UI explanation altered.
  - Temperature settings registers updated for IQS620A.
  - IQS620A: RDY timeout period and I<sup>2</sup>C settings registers added (0xD9 & 0xDA).
- v1.13: Datasheet update:
  - PWM duty cycle register definition updated.
  - IQS620A: Channel reseed enable register (0xDB) added to memory map.
- v1.14: Datasheet update
  - Two channel SAR UI option description added
  - 3 Trigger level description added
- v1.15: Datasheet update
  - Table 5.1 added for calibration value descriptions
- Register 0xC2 and 0xC3 ranges corrected (offset of 1; hex value of 0 = 1 used in equations) v1.16: - Datasheet update
- - Default register values added (hex and binary representation) for all memory map registers.
- v1.17: Datasheet update
  - Device package clearance to MSL1. Specifications amended.
- v1.18: Datasheet update
  - I<sup>2</sup>C stop-bit disable functionality explained. Section 7.4 added.
- v1.19: Datasheet update
  - WLCSP-9 package detail added.
- v1.20: Datasheet update
  - WLCSP-9 pinout-corrected and naming changed to package convention standard.
  - Voltage regulation specifications added (Table 9.2).
- v1.21: Datasheet update
  - WLCSP-9 package dimensions corrected.
  - ProxFusion<sup>®</sup> updated to registered trademark.
- v1.22: Datasheet update
  - Hall-effect sensing operational range confirmed and updated to 10mT 200mT.
  - Section 1.5 ProxFusion<sup>®</sup> Sensitivity added for ATI algorithm explanation.
  - Section 9.4 & 9.6 added: I<sup>2</sup>C module fall times and slew rates.
  - Section 9.7 updated and illustrated in additional Figure 9.2.
  - Appendix B. Hall ATI added.
- v1.23: Datasheet update
  - Section 9.10 added: Start-up timing specifications.
  - Section 9.3 Reset conditions updated
  - ESD protection certified to pass ±8kV (Human body model).
  - WLCSP-9 tape and reel info added.
  - Appendix A. Contact information updated.
- v1.24 Datasheet update
  - General language and description improvements.
  - General document editing.
    - WLCSP-9 flip chip process mentioned for Hall-effect field orientation warning.
    - Ultra low power mode description elaborated to include NP segment updates.
- v1.25 Datasheet update
  - IQS620AT additional option in both DFN-10 & WLCSP-9 package options.
  - Device firmware update version 2 added. Refer to bug fixes and additional features in errata section.
  - Updated reference schematic and suggestions to include various ESD and EM noise suppression components.
  - Device marking of DFN-10 & WLCSP-9 updated.
  - Ordering code section updated to list all options.
  - Errata section updated for firmware revisions
  - Appendix A. Contact information updated.
- v2.00 Datasheet update
  - Verified and stated maximum supply tolerance at VDDHI minimum = 1.8V (-2%) = 1.764V.
  - Datasheet template updated.





v2.01 – Datasheet corrections

- I<sup>2</sup>C Standard-mode compliant only and not Fast-mode compliant due to fall time minimums exceeded in low bus capacitance scenario's.
- Updated minimum VREG = 1.61V & maximum VREG = 1.71V allowance from updated final testing limits.
- Corrected figures in Table 9.5 I<sup>2</sup>C module output logic fall time specifications.
- v2.02 Datasheet update
  - New device hardware number, register address 0x02 = 0x92 = D'146.
  - Device HW 0x92 (D'146) temperature calibration offset changed to +40.
- I.e. Temperature UI output [decimal] 40 = {reg 0x1B << 8} OR {reg 0x1A} D'40 = Temperature [°C] v2.03 Datasheet update
  - Updated VREG and VDDHI capacitor size recommendations, section 1.3.2 and Table 1.3 additions made.
  - Notice added to System settings register (0xD0) to refrain from main frequency oscillator changes with a simultaneous re-ATI command.
- v3.00 Datasheet update
  - Updates to include device version 3 and associated mark info.

# 12.2 Errata

12.2.1 Product version 0 (Device software number [0x01] = 0x04 = D'04)

Pre-production version release

12.2.2 Product version 1 (Device software number [0x01] = 0x08 = D'08)

Production version 1 release

#### 12.2.3 Product version 2 (Device software number [0x01] = 0x0D = D'13)

Production firmware update.

Bug fixes:

- Temperature UI execution between ch4 & 5 changed to execute unconditionally whether channels are active or disabled.
- SAR UI clearing compensation value at maximum resolved.
- Auto mode timer (0xD6) = D'0 (0ms) or D'1 (500ms) immediately entering ULP mode, even if ULP mode is disabled, resolved.
- For halt timeout conditions, touch flag clearing resolved to occur immediately.
- Fast LTA limit calculation corrected.

Device feature additions:

- Fast debounce of channels 0 5 by removing report rate sleep time while in debounce. Active by default: Bit option added to ProxSettings5 [0x51] bit4: 0 = Fast debounce active in NP & LP mode; 1 = Fast debounce inactive in NP & LP modes.
- Floating gate option added to disable Hall-effect sensors (CH4 & 5) permanently. Required for devices that operate at a supply voltage of 1.8V and require a 5% tolerance on the voltage supply source, not to exceed the maximum regulator load when VDDHI = 1.71V (absolute minimum). Bit option added to OTP bank0: bit7: 0 = Hall-effect sensors active; 1 = Hall-effect sensors disabled.

#### 12.2.4 Product version 3 (Device hardware number [0x02] = 0x92 = D'146)

Production hardware update.

Minor IC hardware revision for yield improvement.

Temperature calibration offset value changed to +40.





# Appendix A. Contact information

	USA	Asia	South Africa
Physical Address	11940 Jollyville Rd Suite 120-S Austin TX 78759 USA	Room 501A, Block A T-Share International Centre Taoyuan Road Nanshan District Shenzhen Guangdong Province PRC	1 Bergsig Avenue Paarl 7646 South Africa
Postal Address	11940 Jollyville Rd Suite 120-S Austin TX 78759 USA	Room 501A, Block A T-Share International Centre Taoyuan Road Nanshan District Shenzhen Guangdong Province PRC	PO Box 3534 Paarl 7620 South Africa
Tel	+1 512 538 1995	+86 755 8303 5294 ext 808	+27 21 863 0033
Email	info@azoteq.com	info@azoteq.com	info@azoteq.com

#### Visit <u>www.azoteq.com</u>

for a list of distributors and worldwide representation.

The following patents relate to the device or usage of the device: US 6,249,089; US 6,952,084; US 6,984,900; US 7,084,526; US 7,084,531; US 8,395,395; US 8,531,120; US 8,659,306; US 8,823,273; US 9,209,803; US 9,360,510; US 9,496,793; US 9,709,614; EP 2,351,220; EP 2,559,164; EP 2,748,927; EP 2,846,465; HK 1,157,080; SA 2001/2151; SA 2006/05363; SA 2014/01541; SA 2015/023634; SA 2017/02224;

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# Appendix B: Hall ATI

Azoteq's ProxFusion<sup>®</sup> Hall technology has ATI Functionality; which ensures stable sensor sensitivity. The ATI functionality is similar to the ATI functionality found in ProxSense<sup>®</sup> technology. The difference is that the Hall ATI requires two channels for a single plate.

Using two channels ensures that the ATI can still be used in the presence of the magnet. The two channels are the inverse of each other, this means that the one channel will sense North and the other South. The two channels being inverted allows the capability of calculating a reference value which will always be the same regardless of the presence of a magnet.

#### Hall reference value:

The equation used to calculate the reference value, per plate:

$$Ref_n = \frac{1}{2 \cdot \left(\frac{1}{P_n} + \frac{1}{P'_n}\right)}$$

#### ATI parameters:

Channel 4/5 Multipliers	Compensation ATI Target x32
Coarse : 1 ~ Fine : 10 ~	100 🗭 16 🍧 512
Auto ATI Mode	
O ATI disabled	
O Partial ATI (all multipliers are fixed)	are fixed)
<ul> <li>Semi-Partial ATI (only coarse multipliers a</li> <li>Full-ATI</li> </ul>	аге пхео)
Auto ATI Base Value	
Q 75	
100	
O 150	
○ 200	

The ATI process adjusts three values (Coarse multiplier, Fine multiplier, Compensation) using two parameters per plate (ATI base and ATI target). The ATI process is used to ensure that the sensor's sensitivity is not severely affected by external influences (Temperature, voltage supply change, etc.).

#### **Coarse and Fine multipliers:**

In the ATI process the compensation is set to 0 and the coarse and fine multipliers are adjusted such that the counts of the reference value (Ref) are roughly the same as the ATI Base value. This means that if the base value is increased, the coarse and fine multipliers should also increase and vice versa.

#### **ATI-Compensation:**

After the coarse and fine multipliers are adjusted, the compensation is adjusted till the reference value (Ref) reaches the ATI target. A higher target means more compensation and therefore more sensitivity on the sensor.

The ATI process ensures that long term temperature changes, or bulk magnetic interference (e.g. the accidental placement of another magnet too close to the setup), do not affect the sensor's ability to detect the intended magnetic change.